MOTOROLA

DSP56854

Preliminary Technical Data

DSP56854 16-bit Digital Signal Processor

- 120 MIPS at 120MHz
- 16K x 16-bit Program SRAM
- 16K x 16-bit Data SRAM
- 1K x 16-bit Boot ROM
- Access up to 2M words of program or 8M data memory
- Chip Select Logic for glue-less interface to ROM and SRAM
- Six (6) independent channels of DMA
- Enhanced Synchronous Serial Interfaces (ESSI)
- Two (2) Serial Communication Interfaces (SCI)

- Serial Port Interface (SPI)
- 8-bit Parallel Host Interface
- General Purpose 16-bit Quad Timer
- JTAG/Enhanced On-Chip Emulation (OnCE™) for unobtrusive, real-time debugging
- Computer Operating Properly (COP)/Watchdog Timer
- Time-of-Day (TOD)
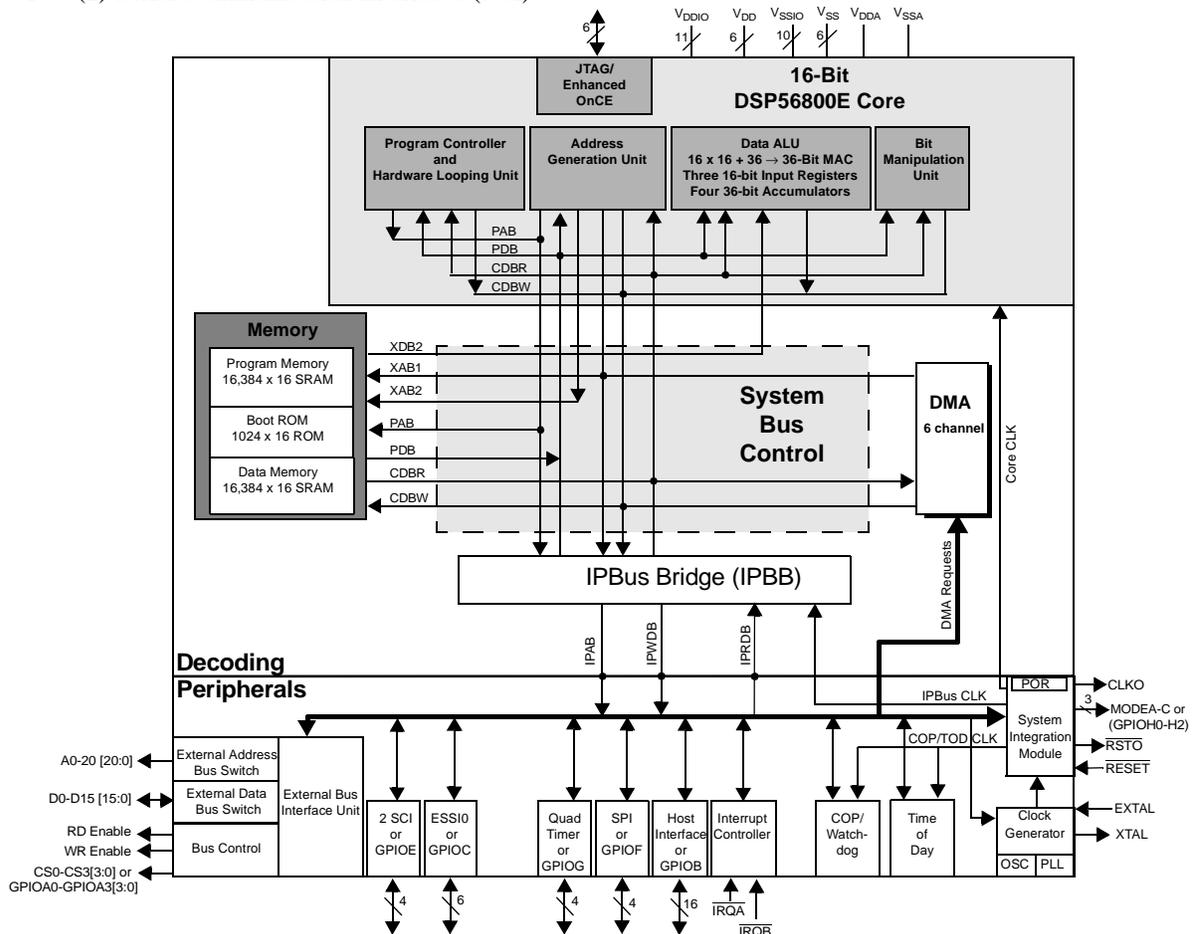- 128 LQFP package
- Up to 41 GPIO

Figure 1. DSP56854 Block Diagram

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Part 1 Overview

1.1 DSP56854 Features

1.1.1   Digital Signal Processing Core

- Efficient 16-bit DSP engine with dual Harvard architecture
- 120 Million Instructions Per Second (MIPS) at 120MHz core frequency
- Single-cycle 16×16-bit parallel Multiplier-Accumulator (MAC)
- Four (4) 36-bit accumulators including extension bits
- 16-bit bidirectional shifter
- Parallel instruction set with unique DSP addressing modes
- Hardware DO and REP loops
- Three (3) internal address buses and one (1) external address bus
- Four (4) internal data buses and one (1) external data bus
- Instruction set supports both DSP and controller functions
- Four (4) hardware interrupt levels
- Five (5) software interrupt levels
- Controller-style addressing modes and instructions for compact code
- Efficient C Compiler and local variable support
- Software subroutine and interrupt stack with depth limited only by memory
- JTAG/Enhanced OnCE debug programming interface

1.1.2   Memory

- Harvard architecture permits up to three (3) simultaneous accesses to program and data memory
- On-Chip Memory
  - $16K \times 16$-bit Program SRAM
  - $16K \times 16$-bit Data SRAM
  - $1K \times 16$-bit Boot ROM
- Off-Chip Memory Expansion (EMI)
  - Access up to 2M words of program memory or up to 8M words of data memory
  - Chip Select Logic for glue-less interface to ROM and SRAM

1.1.3   Peripheral Circuits for DSP56854

- General Purpose 16-bit Quad Timer*
- Two (2) Serial Communication Interfaces (SCI)*
- Serial Peripheral Interface (SPI) Port*
- Enhanced Synchronous Serial Interface (ESSI) module*
- Computer Operating Properly (COP)/Watchdog Timer

- JTAG/Enhanced On-Chip Emulation (EOnCE) for unobtrusive, real-time debugging

- Six (6) independent channels of DMA

- 8-bit Parallel Host Interface*

- Time of Day

- Up to 41 GPIO

* Each peripheral I/O can be used alternately as a General Purpose I/O if not needed

1.1.4   Energy Information

- Fabricated in high-density CMOS with 3.3V, TTL-compatible digital inputs

- Wait and Stop modes available

1.2 DSP56854 Description

The DSP56854 is a member of the DSP56800E core-based family of Digital Signal Processors (DSPs). It combines, on a single chip, the processing power of a DSP and the functionality of a microcontroller with a flexible set of peripherals to create an extremely cost-effective solution. Because of its low cost, configuration flexibility, and compact program code, the DSP56854 is well-suited for many applications. The DSP56854 includes many peripherals that are especially useful for low-end Internet appliance applications and low-end client applications such as telephony; portable devices; Internet audio; and point-of-sale systems, such as noise suppression; ID tag readers; sonic/subsonic detectors; security access devices; remote metering; sonic alarms.

The Product Family core is based on a Harvard-style architecture consisting of three execution units operating in parallel, allowing as many as six operations per instruction cycle. The microprocessor-style programming model and optimized instruction set allow straightforward generation of efficient, compact code for both DSP and MCU applications. The instruction set is also highly efficient for C Compilers, enabling rapid development of optimized control applications.

The DSP56854 supports program execution from either internal or external memories. Two data operands can be accessed from the on-chip Data RAM per instruction cycle. The DSP56854 also provides two external dedicated interrupt lines, and up to 41 General Purpose Input/Output (GPIO) lines, depending on peripheral configuration.

The DSP56854 DSP controller includes 16K words of Program RAM, 16K words of Data RAM, and 1K words of Boot ROM. It also supports program execution from external memory.

This DSP controller also provides a full set of standard programmable peripherals that include an 8-bit parallel Host Interface, Enhanced Synchronous Serial Interface (ESSI), one Serial Peripheral Interface (SPI), two Serial Communications Interfaces (SCIs), and a Quad Timer. The Host Interface, ESSI, SPI, SCI, four chip selects and quad timer can be used as General Purpose Input/Outputs (GPIOs) if its primary function is not required.

1.3 "Best in Class" Development Environment

The SDK (Software Development Kit) provides fully-debugged peripheral drivers, libraries and interfaces that allow a programmer to create his own unique C application code independent of component architecture. The CodeWarrior Integrated Development Environment is a sophisticated tool for code navigation, compiling, and debugging. A complete set of evaluation modules (EVMs) and development system cards will support concurrent engineering. Together, the SDK, CodeWarrior, and EVMs create a complete, scalable tools solution for easy, fast and efficient development.

1.4 Product Documentation

The four documents listed in **Table 1** are required for a complete description of and proper design with the DSP56854. Documentation is available from local Motorola distributors, Motorola semiconductor sales offices, Motorola Literature Distribution Centers, or online at www.motorola.com/semiconductors/.

Table 1. DSP56854 Chip Documentation

Topic	Description	Order Number
DSP56800E Reference Manual	Detailed description of the DSP56800E architecture, 16-bit DSP core processor and the instruction set	DSP56800ERM/D
DSP56854 User's Manual	Detailed description of memory, peripherals, and interfaces of the DSP56854	DSP5685xUM/D
DSP56854 Technical Data Sheet	Electrical and timing specifications, pin descriptions, and package descriptions	DSP56854/D
DSP56854 Product Brief	Summary description and block diagram of the DSP56854 core, memory, peripherals and interfaces (this document)	DSP56854PB/D

1.5 Data Sheet Conventions

This data sheet uses the following conventions:

$\overline{\text{OVERBAR}}$	This is used to indicate a signal that is active when pulled low. For example, the $\overline{\text{RESET}}$ pin is active when low.
"asserted"	A high true (active high) signal is high or a low true (active low) signal is low.
"deasserted"	A high true (active high) signal is low or a low true (active low) signal is high.

Examples:	Signal/Symbol	Logic State	Signal State	Voltage[1]
	$\overline{\text{PIN}}$	True	Asserted	V_{IL}/V_{OL}
	$\overline{\text{PIN}}$	False	Deasserted	V_{IH}/V_{OH}
	PIN	True	Asserted	V_{IH}/V_{OH}
	PIN	False	Deasserted	V_{IL}/V_{OL}

1. Values for VIL, VOL, VIH, and VOH are defined by individual product specifications.

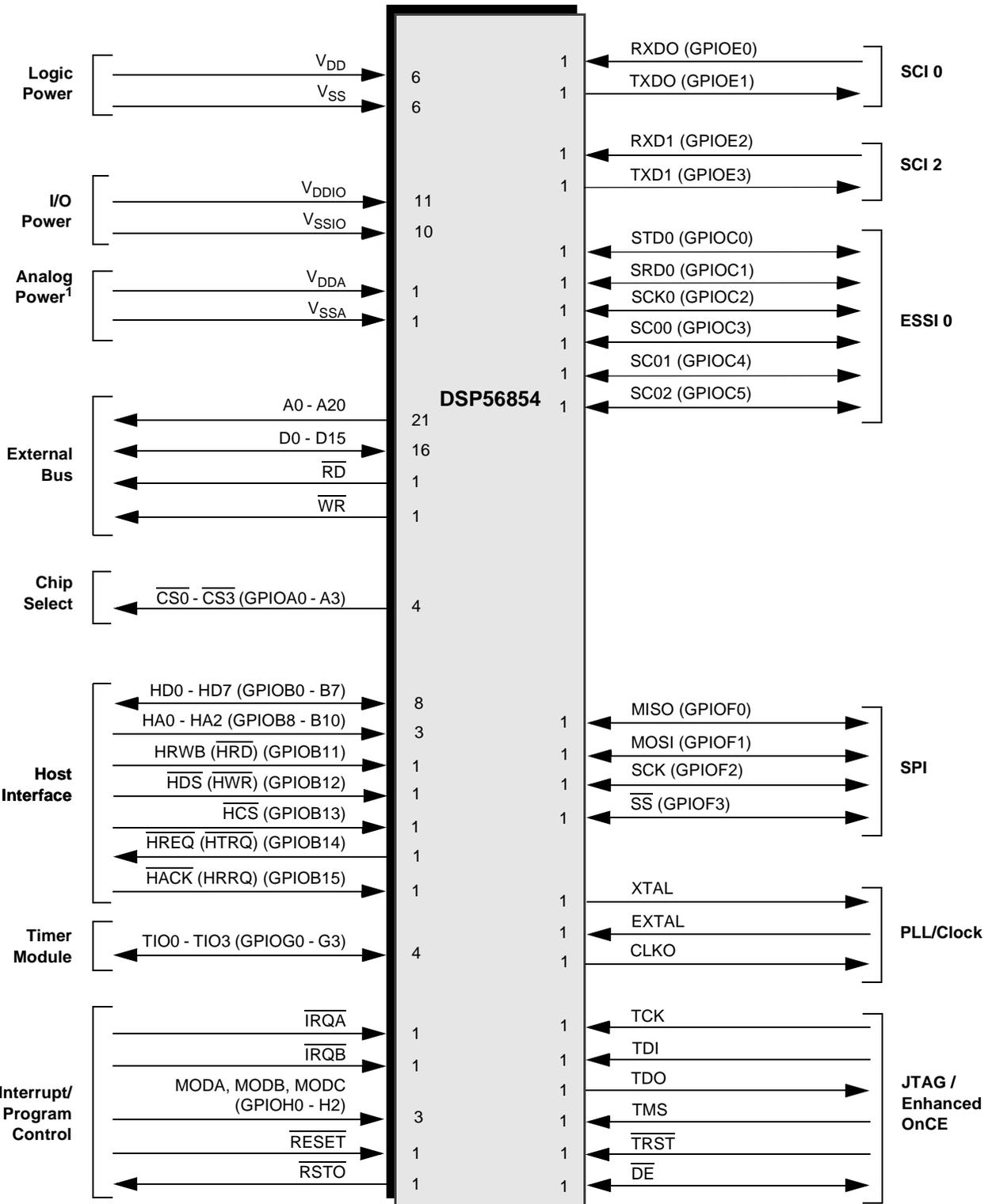# Part 2 Signal/Connection Descriptions

2.1 Introduction

The input and output signals of the DSP56854 are organized into functional groups, as shown in **Table 2** and as illustrated in **Figure 2**. In **Table 3** each table row describes the package pin and the signal or signals present.

Table 2. Functional Group Pin Allocations

Functional Group	Number of Pins
Power (V_{DD}, $V_{DDIO,}$ or V_{DDA})	$(6, 11, 1)^1$
Ground (V_{SS}, $V_{SSIO,}$or V_{SSA})	$(6, 10, 1)^1$
PLL and Clock	3
External Bus Signals	39
External Chip Select*	4
Interrupt and Program Control	7^2
Host Interface (HI)*	16^3
Enhanced Synchronous Serial Interface (ESSI0) Port*	6
Serial Communications Interface (SCI0) Ports*	2
Serial Communications Interface (SCI1) Ports*	2
Serial Peripheral Interface (SPI) Port*	4
Quad Timer Module Port*	4
JTAG/Enhanced On-Chip Emulation (EOnCE)	6

 *Alternately, GPIO pins

1. V_{DD} = $V_{DD\ CORE,}$ V_{SS} = $V_{SS\ CORE}$, V_{DDIO}= $V_{DD\ IO}$, V_{SSIO} = $V_{SS\ IO}$, V_{DDA} = $V_{DD\ ANA}$, V_{SSA} = $V_{SS\ ANA}$
2. MODA, MODB and MODC can be used as GPIO after the bootstrap process has completed.
3. The following Host Interface signals are multiplexed: HRWB to $\overline{HRD}$, $\overline{HDS}$ to $\overline{HWR}$, $\overline{HREQ}$ to $\overline{HTRQ}$ and $\overline{HACK}$ to HRRQ.

Logic Power — V$_{DD}$ 6 / V$_{SS}$ 6

I/O Power — V$_{DDIO}$ 11 / V$_{SSIO}$ 10

Analog Power[1] — V$_{DDA}$ 1 / V$_{SSA}$ 1

External Bus — A0 - A20 21 / D0 - D15 16 / $\overline{RD}$ 1 / $\overline{WR}$ 1

Chip Select — $\overline{CS0}$ - $\overline{CS3}$ (GPIOA0 - A3) 4

Host Interface — HD0 - HD7 (GPIOB0 - B7) 8 / HA0 - HA2 (GPIOB8 - B10) 3 / HRWB ($\overline{HRD}$) (GPIOB11) 1 / $\overline{HDS}$ ($\overline{HWR}$) (GPIOB12) 1 / $\overline{HCS}$ (GPIOB13) 1 / $\overline{HREQ}$ ($\overline{HTRQ}$) (GPIOB14) 1 / $\overline{HACK}$ (HRRQ) (GPIOB15) 1

Timer Module — TIO0 - TIO3 (GPIOG0 - G3) 4

Interrupt/ Program Control — $\overline{IRQA}$ 1 / $\overline{IRQB}$ 1 / MODA, MODB, MODC (GPIOH0 - H2) 3 / $\overline{RESET}$ 1 / $\overline{RSTO}$ 1

DSP56854

SCI 0 — RXDO (GPIOE0) 1 / TXDO (GPIOE1) 1

SCI 2 — RXD1 (GPIOE2) 1 / TXD1 (GPIOE3) 1

ESSI 0 — STD0 (GPIOC0) 1 / SRD0 (GPIOC1) 1 / SCK0 (GPIOC2) 1 / SC00 (GPIOC3) 1 / SC01 (GPIOC4) 1 / SC02 (GPIOC5) 1

SPI — MISO (GPIOF0) 1 / MOSI (GPIOF1) 1 / SCK (GPIOF2) 1 / $\overline{SS}$ (GPIOF3) 1

PLL/Clock — XTAL 1 / EXTAL 1 / CLKO 1

JTAG / Enhanced OnCE — TCK 1 / TDI 1 / TDO 1 / TMS 1 / $\overline{TRST}$ 1 / $\overline{DE}$ 1

Figure 2. DSP56854 Signals Identified by Functional Group[2]

1. Specifically for PLL, OSC, and POR.

2. Alternate pin functions are shown in parentheses.

Part 3 Signals and Package Information

All digital inputs have a weak internal pull-up circuit associated with them. These pull-up circuits are enabled by default. Exceptions:

1. When a pin has GPIO functionality, the pull-up may be disabled under software control.

2. MODE A, MODE B and MODE C pins have no pull-up.

3. TCK has a weak pull-down circuit always active.

4. Bidirectional I/O pullups automatically disable when the output is enabled.

This table is presented consistently with the *Signals Identified by Functional Group* figure.

1. **BOLD** entries in the *Type* column represents the state of the pin just out of reset.

2. Ouput(Z) means an output in a High-Z condition.

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
13	V_{DD}	V_{DD}	**Power (V_{DD})**—These pins provide power to the internal structures of the chip, and should all be attached to $V_{DD.}$
47	V_{DD}		
64	V_{DD}		
79	V_{DD}		
80	V_{DD}		
112	V_{DD}		
14	V_{SS}	V_{SS}	**Ground (V_{SS})**—These pins provide grounding for the internal structures of the chip and should all be attached to V_{SS}.
48	V_{SS}		
63	V_{SS}		
81	V_{SS}		
96	V_{SS}		
113	V_{SS}		

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
5	V_{DDIO}	V_{DDIO}	**Power (V_{DDIO})**—These pins provide power for all I/O and ESD structures of the chip, and should all be attached to V_{DDIO} (3.3V).
18	V_{DDIO}		
41	V_{DDIO}		
55	V_{DDIO}		
61	V_{DDIO}		
72	V_{DDIO}		
91	V_{DDIO}		
92	V_{DDIO}		
100	V_{DDIO}		
114	V_{DDIO}		
124	V_{DDIO}		
6	V_{SSIO}	V_{SSIO}	**Ground (V_{SSIO})**—These pins provide grounding for all I/O and ESD structures of the chip and should all be attached to V_{SS}.
19	V_{SSIO}		
42	V_{SSIO}		
56	V_{SSIO}		
62	V_{SSIO}		
74	V_{SSIO}		
93	V_{SSIO}		
102	V_{SSIO}		
115	V_{SSIO}		
125	V_{SSIO}		
22	V_{DDA}	V_{DDA}	**Analog Power (V_{DDA})**—These pins supply an analog power source.
23	V_{SSA}	V_{SSA}	**Analog Ground (V_{SSA})**—This pin supplies an analog ground.

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
9	A0	**Output(Z)**	**Address Bus (A0-A20)**—These signals specify a word address for external program or data memory access.
10	A1		
11	A2		
12	A3		
26	A4		
27	A5		
28	A6		
29	A7		
43	A8		
44	A9		
45	A10		
46	A11		
57	A12		
58	A13		
59	A14		
60	A15		
67	A16		
68	A17		
69	A18		
70	A19		
71	A20	**Output(Z)**	

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
73	D0	**Input**/Output(Z)	**Data Bus (D0-D15)**—These pins provide the bidirectional data for external program or data memory accesses.
86	D1		
87	D2		
88	D3		
89	D4		
90	D5		
107	D6		
108	D7		
109	D8		
110	D9		
111	D10		
122	D11		
123	D12		
126	D13		
127	D14		
128	D15		
7	$\overline{RD}$	Output	**Read Enable ($\overline{RD}$)** —is asserted during external memory read cycles. This signal is pulled high during reset.
8	$\overline{WR}$	Output	**Write Enable ($\overline{WR}$)**— is asserted during external memory write cycles. This signal is pulled high during reset.
75	$\overline{CS0}$	**Output**	**External Chip Select ($\overline{CS0}$)**—This pin is used as a dedicated GPIO.
	GPIOA0	**Input**/Output	**Port A GPIO (0**) —This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
76	$\overline{CS1}$	**Output**	**External Chip Select ($\overline{CS1}$)**—This pin is used as a dedicated GPIO.
	GPIOA1	**Input**/Output	**Port A GPIO (1)** —This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
77	$\overline{CS2}$	**Output**	**External Chip Select ($\overline{CS2}$)**—This pin is used as a dedicated GPIO.
	GPIOA2	**Input**/Output	**Port A GPIO (2)** —This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
78	$\overline{CS3}$	**Output**	**External Chip Select ($\overline{CS3}$)**—This pin is used as a dedicated GPIO.
	GPIOA3	**Input**/Output	**Port A GPIO (3)**—This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
30	HD0	**Input**	**Host Address (HD0)—**This input provides data selection for HI registers. This pin is disconnected internally during reset.
	GPIOB0	Input/Output	**Port B GPIO (0)**—This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
31	HD1	**Input**	**Host Address (HD1)—**This input provides data selection for HI registers. This pin is disconnected internally during reset.
	GPIOB1	Input/Output	**Port B GPIO (1)**—This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
32	HD2	**Input**	**Host Address (HD2)—**This input provides data selection for HI registers. This pin is disconnected internally during reset.
	GPIOB2	Input/Output	**Port B GPIO (2)**—This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
36	HD3	**Input**	**Host Address (HD3)—**This input provides data selection for HI registers. This pin is disconnected internally during reset.
	GPIOB3	Input/Output	**Port B GPIO (3)**—This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
37	HD4	**Input**	**Host Address (HD4)—**This input provides data selection for HI registers. This pin is disconnected internally during reset.
	GPIOB4	Input/Output	**Port B GPIO (4)**—This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
38	HD5	**Input**	**Host Address (HD5)—**This input provides data selection for HI registers. This pin is disconnected internally during reset.
	GPIOB5	Input/Output	**Port B GPIO (5)—**This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
39	HD6	**Input**	**Host Address (HD6)—**This input provides data selection for HI registers. This pin is disconnected internally during reset.
	GPIOB6	Input/Output	**Port B GPIO (6)—**This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
40	HD7	**Input**	**Host Address (HD7)—**This input provides data selection for HI registers. This pin is disconnected internally during reset.
	GPIOB7	Input/Output	**Port B GPIO (7)—**This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
82	HA0	**Input**	**Host Address (HA0)—**These inputs provide the address selection for HI registers. These pins are disconnected internally during reset.
	GPIOB8	Input/Output	**Port B GPIO (8)—**These pins are General Purpose I/O (GPIO) pins when not configured for host port usage.
83	HA1	**Input**	**Host Address (HA0)—**These inputs provide the address selection for HI registers. These pins are disconnected internally during reset.
	GPIOB9	Input/Output	**Port B GPIO (9)—**These pins are General Purpose I/O (GPIO) pins when not configured for host port usage.
84	HA2	**Input**	**Host Address (HA0)—**These inputs provide the address selection for HI registers. These pins are disconnected internally during reset.
	GPIOB10	Input/Output	**Port B GPIO (10)—**These pins are General Purpose I/O (GPIO) pins when not configured for host port usage.

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
85	HRWB	**Input**	**Host Read/Write (HRWB)**—When the HI08 is programmed to interface to a single-data-strobe host bus and the HI function is selected, this signal is the Read/Write input. These pins are disconnected internally.
	$\overline{\text{HRD}}$	Input	**Host Read Data ($\overline{\text{HRD}}$)**—This signal is the Read Data input when the HI08 is programmed to interface to a double-data-strobe host bus and the HI function is selected.
	GPIOB11	Input/Output	**Port B GPIO (11)**—This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
103	$\overline{\text{HDS}}$	**Input**	**Host Data Strobe ($\overline{\text{HDS}}$)**—When the HI08 is programmed to interface to a single-data-strobe host bus and the HI function is selected, this input enables a data transfer on the HI when HCS is asserted. These pins are disconnected internally.
	$\overline{\text{HWR}}$	Input	**Host Write Enable ($\overline{\text{HWR}}$)**—This signal is the Write Data input when the HI08 is programmed to interface to a double-data-strobe host bus and the HI function is selected.
	GPIOB12	Input/Outpu0	**Port B GPIO (12)**—This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
104	$\overline{\text{HCS}}$	**Input**	**Host Chip Select ($\overline{\text{HCS}}$)**—This input is the chip select input for the Host Interface. These pins are disconnected internally.
	GPIOB13	Input/Output	**Port B GPIO (13)**—This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
105	$\overline{\text{HREQ}}$	**Open Drain Output**	**Host Request ($\overline{\text{HREQ}}$)**—When the HI08 is programmed for HRMS=0 functionality (typically used on a single-data-strobe bus), this open drain output is used by the HI to request service from the host processor. The $\overline{\text{HREQ}}$ may be connected to an interrupt request pin of a host processor, a transfer request of a DMA controller, or a control input of external circuitry. These pins are disconnected internally.
	$\overline{\text{HTRQ}}$	Open Drain Output	**Transmit Host Request ($\overline{\text{HTRQ}}$)**—This signal is the Transmit Host Request output when the HI08 is programmed for HRMS=1 functionality and is typically used on a double-data-strobe bus.
	GPIOB14	Input/Output	**Port B GPIO (14)**—This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
106	$\overline{\text{HACK}}$	Input	**Host Acknowledge (HACK)**—When the HI08 is programmed for HRMS=0 functionality (typically used on a single-data-strobe bus), this input has two functions: (1) provide a Host Acknowledge signal for DMA transfers or (2) to control handshaking and provide a Host Interrupt Acknowledge compatible with the MC68000 family processors. These pins are disconnected internally.
	HRRQ	Open Drain Output	**Receive Host Request (HRRQ)**—This signal is the Receive Host Request output when the HI08 is programmed for HRMS=1 functionality and is typically used on a double-data-strobe bus.
	GPIOB15	Input/Output	**Port B GPIO(15)**—This pin is a General Purpose I/O (GPIO) pin when not configured for host port usage.
101	TIO0	**Input**/Output	**Timer Input/Outputs (TIO0)**—This pin can be independently configured to be either a timer input source or an output flag.
	GPIOG0	Input/Output	**Port G GPIOG0**—This pin is a General Purpose I/O (GPIO) pin that can individually be programmed as an input or output pin.
99	TIO1	**Input**/Output	**Timer Input/Outputs (TIO1)**—This pin can be independently configured to be either a timer input source or an output flag.
	GPIOG1	Input/Output	**Port G GPIO (1)**—This pin is a General Purpose I/O (GPIO) pin that can individually be programmed as an input or output pin.
98	TIO2	**Input**/Output	**Timer Input/Outputs (TIO2)**—This pin can be independently configured to be either a timer input source or an output flag.
	GPIOG2	Input/Output	**Port G GPIO (2)**—This pin is a General Purpose I/O (GPIO) pin that can individually be programmed as an input or output pin.
97	TIO3	**Input**/Output	**Timer Input/Outputs (TIO3)**—This pin can be independently configured to be either a timer input source or an output flag.
	GPIOG3	Input/Output	**Port G GPIO (3)**—This pin is a General Purpose I/O (GPIO) pin that can individually be programmed as an input or output pin.

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
20 21	$\overline{IRQA}$ $\overline{IRQB}$	Input	**External Interrupt Request A and B**—The $\overline{IRQA}$ and $\overline{IRQB}$ inputs are asynchronous external interrupt requests that indicate that an external device is requesting service. A Schmitt trigger input is used for noise immunity. They can be programmed to be level-sensitive or negative-edge-triggered. If level-sensitive triggering is selected, an external pull-up resistor is required for Wired-OR operation.
15	MODA GPIOH0	**Input** Input/Output	**Mode Select (MODA)**—During the bootstrap process MODA selects one of the eight bootstrap modes. **Port H GPIO (0)**—This pin is a General Purpose I/O (GPIO) pin after the bootstrap process has completed.
16	MODB GPIOH1	**Input** Input/Output	**Mode Select (MODB)**—During the bootstrap process MODB selects one of the eight bootstrap modes. **Port H GPIO (1)**—This pin is a General Purpose I/O (GPIO) pin after the bootstrap process has completed.
17	MODC GPIOH2	**Input** Input/Output	**Mode Select (MODC)**—During the bootstrap process MODC selects one of the eight bootstrap modes. **Port H GPIO (2)**—This pin is a General Purpose I/O (GPIO) pin after the bootstrap process has completed.
35	$\overline{RESET}$	Input	**Reset ($\overline{RESET}$)**—This input is a direct hardware reset on the processor. When $\overline{RESET}$ is asserted low, the DSP is initialized and placed in the Reset state. A Schmitt trigger input is used for noise immunity. When the $\overline{RESET}$ pin is deasserted, the initial chip operating mode is latched from the MODA, MODB, and MODC pins. To ensure complete hardware reset, $\overline{RESET}$ and $\overline{TRST}$ should be asserted together. The only exception occurs in a debugging environment when a hardware DSP reset is required and it is necessary not to reset the JTAG/Enhanced OnCE module. In this case, assert $\overline{RESET}$, but do not assert $\overline{TRST}$.
34	$\overline{RSTO}$	Output	**Reset Output ($\overline{RSTO}$)**—This output is asserted on any reset condition (external reset, low voltage, software or COP).
65	RXD0 GPIOE0	**Input** Input/Output	**Serial Receive Data 0 (RXD0)**—This input receives byte-oriented serial data and transfers it to the SCI 0 receive shift register. **Port E GPIO (0)**—This pin is a General Purpose I/O (GPIO) pin that can individually be programmed as input or output pin.

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
66	TXD0	**Output(Z)**	**Serial Transmit Data 0 (TXD0)**—This signal transmits data from the SCI 0 transmit data register.
	GPIOE1	Input/Output	**Port E GPIO (1)**—This pin is a General Purpose I/O (GPIO) pin that can individually be programmed as input or output pin.
94	RXD1	**Input**	**Serial Receive Data 1 (RXD1)**—This input receives byte-oriented serial data and transfers it to the SCI 1 receive shift register.
	GPIOE2	Input/Output	**Port E GPIO (2)**—This pin is a General Purpose I/O (GPIO) pin that can individually be programmed as input or output pin.
95	TXD1	**Output(Z)**	**Serial Transmit Data 1 (TXD1)**—This signal transmits data from the SCI 1 transmit data register.
	GPIOE3	Input/Output	**Port E GPIO (3)**—This pin is a General Purpose I/O (GPIO) pin that can individually be programmed as input or output pin.
116	STD0	**Output**	**ESSI Transmit Data (STD0)**—This output pin transmits serial data from the ESSI Transmitter Shift Register.
	GPIOC0	**Input**/Output	**Port C GPIO (0)**—This pin is a General Purpose I/O (GPIO) pin when the ESSI is not in use.
117	SRD0	**Input**	**ESSI Receive Data (SRD0)**—This input pin receives serial data and transfers the data to the ESSI Receive Shift Register.
	GPIOC1	**Input**/Output	**Port C GPIO (1)**—This pin is a General Purpose I/O (GPIO) pin when the ESSI is not in use.
118	SCK0	**Input**/Output	**ESSI Serial Clock (SCK0)**—This bidirectional pin provides the serial bit rate clock for the transmit section of the ESSI. The clock signal can be continuous or gated and can be used by both the transmitter and receiver in synchronous mode.
	GPIOC2	Input/Output	**Port C GPIO (2)**—This pin is a General Purpose I/O (GPIO) pin when the ESSI is not in use.
119	SC00	**Input**/Output	**ESSI Serial Control Pin 0 (SC00)**—The function of this pin is determined by the selection of either synchronous or asynchronous mode. For asynchronous mode, this pin will be used for the receive clock I/O. For synchronous mode, this pin is used either for transmitter1 output or for serial I/O flag 0.
	GPIOC3	Input/Output	**Port C GPIO (3)**—This pin is a General Purpose I/O (GPIO) pin when the ESSI is not in use.

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
120	SC01	**Input**/Output	**ESSI Serial Control Pin 1 (SC01)**—The function of this pin is determined by the selection of either synchronous or asynchronous mode. For asynchronous mode, this pin is the receiver frame sync I/O. For synchronous mode, this pin is used either for transmitter2 output or for serial I/O flag 1.
	GPIOC4	Input/Output	**Port C GPIO (4)**—This pin is a General Purpose I/O (GPIO) pin when the ESSI is not in use.
121	SC02	**Input**/Output	**ESSI Serial Control Pin 2 (SC02)**—This pin is used for frame sync I/O. SC02 is the frame sync for both the transmitter and receiver in synchronous mode and for the transmitter only in asynchronous mode. When configured as an output, this pin is the internally generated frame sync signal. When configured as an input, this pin receives an external frame sync signal for the transmitter (and the receiver in synchronous operation).
	GPIOC5	Input /Output	**Port C GPIO (5)**—This pin is a General Purpose I/O (GPIO) pin when the ESSI is not in use.
1	MISO	**Input**/Output	**SPI Master In/Slave Out (MISO)**—This serial data pin is an input to a master device and an output from a slave device. The MISO line of a slave device is placed in the high-impedance state if the slave device is not selected. The driver on this pin can be configured as an open-drain driver by the SPI's Wired-OR mode (WOM) bit when this pin is configured for SPI operation.
	GPIOF0	Input/Output	**Port F GPIO (0)**—This pin is a General Purpose I/O (GPIO) pin that can be individually programmed as input or output pin.
2	MOSI	Input**/Output (Z)**	**SPI Master Out/Slave In (MOSI)**—This serial data pin is an output from a master device and an input to a slave device. The master device places data on the MOSI line a half-cycle before the clock edge that the slave device uses to latch the data. The driver on this pin can be configured as an open-drain driver by the SPI's WOM bit when this pin is configured for SPI operation.
	GPIOF1	Input/Output	**Port F GPIO (1)**—This pin is a General Purpose I/O (GPIO) pin that can individually be programmed as input or output pin.

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
3	SCK	**Input**/Output	**SPI Serial Clock (SCK)**—This bidirectional pin provides a serial bit rate clock for the SPI. This gated clock signal is an input to a slave device and is generated as an output by a master device. Slave devices ignore the SCK signal unless the $\overline{\text{SS}}$ pin is active low. In both master and slave SPI devices, data is shifted on one edge of the SCK signal and is sampled on the opposite edge, where data is stable. The driver on this pin can be configured as an open-drain driver by the SPI's WOM bit when this pin is configured for SPI operation. When using Wired-OR mode, the user must provide an external pull-up device.
	GPIOF2	Input/Output	**Port F GPIO (2)**—This pin is a General Purpose I/O (GPIO) pin that can be individually programmed as input or output pin.
4	$\overline{\text{SS}}$	**Input**	**SPI Slave Select ($\overline{\text{SS}}$)**—This input pin selects a slave device before a master device can exchange data with the slave device. $\overline{\text{SS}}$ must be low before data transactions and must stay low for the duration of the transaction. The $\overline{\text{SS}}$ line of the master must be held high.
	GPIOF3	Input/Output	**Port F GPIO (3)**—This pin is a General Purpose I/O (GPIO) pin that can individually be programmed as input or output pin.
24	XTAL	Input/**Output**	**Crystal Oscillator Output (XTAL)**—This output connects the internal crystal oscillator output to an external crystal. If an external clock source other than a crystal oscillator is used, XTAL must be used as the input.
25	EXTAL	Input	**External Crystal Oscillator Input (EXTAL)**—This input should be connected to an external crystal. If an external clock source other than a crystal oscillator is used, EXTAL must be tied off. See Section 4.5.2
33	CLKO	Output	**Clock Output (CLKO)**—This pin outputs a buffered clock signal. When enabled, this signal is the system clock divided by four.
54	TCK	Input	**Test Clock Input (TCK)**—This input pin provides a gated clock to synchronize the test logic and to shift serial data to the JTAG/Enhanced OnCE port. The pin is connected internally to a pull-down resistor.
52	TDI	Input	**Test Data Input (TDI)**—This input pin provides a serial input data stream to the JTAG/Enhanced OnCE port. It is sampled on the rising edge of TCK and has an on-chip pull-up resistor.
51	TDO	Output (Z)	**Test Data Output (TDO)**—This tri-statable output pin provides a serial output data stream from the JTAG/Enhanced OnCE port. It is driven in the Shift-IR and Shift-DR controller states, and changes on the falling edge of TCK.

Table 3. DSP56854 Signal and Package Information for the 128-pin LQFP

Pin No.	Signal Name	Type	Description
53	TMS	Input	**Test Mode Select Input (TMS)**—This input pin is used to sequence the JTAG TAP controller's state machine. It is sampled on the rising edge of TCK and has an on-chip pull-up resistor.
50	$\overline{\text{TRST}}$	Input	**Test Reset (TRST)**—As an input, a low signal on this pin provides a reset signal to the JTAG TAP controller. To ensure complete hardware reset, $\overline{\text{TRST}}$ should be asserted whenever $\overline{\text{RESET}}$ is asserted. The only exception occurs in a debugging environment, since the Enhanced OnCE/JTAG module is under the control of the debugger. In this case it is not necessary to assert $\overline{\text{TRST}}$ when asserting $\overline{\text{RESET}}$. Outside of a debugging environment $\overline{\text{RESET}}$ should be permanently asserted by grounding the signal, thus disabling the Enhanced OnCE/JTAG module on the DSP.
49	$\overline{\text{DE}}$	**Input**/Output	**Debug Event (DE)**—This is an open-drain, bidirectional, active low signal. As an input, it is a means of entering debug mode of operation from an external command controller. As an output, it is a means of acknowledging that the chip has entered debug mode. This pin is connected internally to a weak pull-up resistor.

Part 4 Specifications

4.1 General Characteristics

The DSP56854 is fabricated in high-density CMOS with 5-volt tolerant TTL-compatible digital inputs. The term "5-volt tolerant" refers to the capability of an I/O pin, built on a 3.3V compatible process technology, to withstand a voltage up to 5.5V without damaging the device. Many systems have a mixture of devices designed for 3.3V and 5V power supplies. In such systems, a bus may carry both 3.3V and 5V-compatible I/O voltage levels (a standard 3.3V I/O is designed to receive a maximum voltage of 3.3V $\pm$ 10% during normal operation without causing damage). This 5V tolerant capability therefore offers the power savings of 3.3V I/O levels while being able to receive 5V levels without being damaged.

Absolute maximum ratings given in **Table 4** are stress ratings only, and functional operation at the maximum is not guaranteed. Stress beyond these ratings may affect device reliability or cause permanent damage to the device.

The DSP56854 DC/AC electrical specifications are preliminary and are from design simulations. These specifications may not be fully tested or guaranteed at this early stage of the product life cycle. Finalized specifications will be published after complete characterization and device qualifications have been completed.

CAUTION

This device contains protective circuitry to guard against damage due to high static voltage or electrical fields. However, normal precautions are advised to avoid application of any voltages higher than maximum rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate voltage level.

Table 4. Absolute Maximum Ratings

Characteristic	Symbol	Min	Max	Unit
Supply voltage, core	V_{DD}[1]	$V_{SS} - 0.3$	$V_{SS} + 2.0$	V
Supply voltage, IO Supply voltage, analog	V_{DDIO}[2] V_{DDIO}[2]	$V_{SSIO} - 0.3$ $V_{SSA} - 0.3$	$V_{SSIO} + 4.0$ $V_{DDA} + 4.0$	V
Digital input voltages Analog input voltages (XTAL, EXTAL)	V_{IN} V_{INA}	$V_{SSIO} - 0.3$ $V_{SSA} - 0.3$	$V_{SSIO} + 5.5$ $V_{DDA} + 0.3$	V
Current drain per pin excluding V_{DD}, GND	I	—	8	mA
Junction temperature	T_J	-40	120	°C
Storage temperature range	T_{STG}	-55	150	°C

1. V_{DD} must not exceed V_{DDIO}

2. V_{DDIO} and V_{DDA} must not differ by more that 0.5V

Table 5. Recommended Operating Conditions

Characteristic	Symbol	Min	Max	Unit
Supply voltage for Logic Power	V_{DD}	1.62	1.98	V
Supply voltage for I/O Power	V_{DDIO}	3.0	3.6	V
Supply voltage for Analog Power	V_{DDA}	3.0	3.6	V
Ambient operating temperature	T_A	-40	85	°C
PLL clock frequency[1]	f_{pll}	—	240	MHz
Operating Frequency[2]	f_{op}	—	120	MHz
Frequency of peripheral bus	f_{ipb}	—	60	MHz
Frequency of external clock	f_{clk}	—	240	MHz
Frequency of oscillator	f_{osc}	2	4	MHz
Frequency of clock via XTAL	f_{xtal}	—	240	MHz
Frequency of clock via EXTAL	f_{extal}	2	4	MHz

1. Assumes clock source is direct clock to EXTAL or crystal oscillator running 2-4MHz. PLL must be enabled, locked, and selected. The actual frequency depends on the source clock frequency and programming of the CGM module.

2. Master clock is derived from on of the following four sources:

$f_{clk} = f_{xtal}$ when the source clock is the direct clock to EXTAL

$f_{clk} = f_{pll}$ when PLL is selected

$f_{clk} = f_{osc}$ when the source clock is the crystal oscillator and PLL is not selected

$f_{clk} = f_{extal}$ when the source clock is the direct clock to EXTAL and PLL is not selected

Table 6. Thermal Characteristics[1]

Characteristic	128-pin LQFP		
	Symbol	Value	Unit
Thermal resistance junction-to-ambient (estimated)	θ_{JA}	43.1	°C/W
I/O pin power dissipation	$P_{I/O}$	User Determined	W
Power dissipation	P_D	$P_D = (I_{DD} \times V_{DD}) + P_{I/O}$	W
Maximum allowed P_D	P_{DMAX}	$(T_J - T_A) / \theta_{JA}$	×C

1. See **Section 6.1** for more detail.

4.2 DC Electrical Characteristics

Table 7. DC Electrical Characteristics

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62$-1.98V, $V_{DDIO} = V_{DDA} = 3.0$–3.6V, $T_A = -40°$ to $+120°$C, $C_L \leq 50$pF, $f_{op} = 120$MHz

Characteristic	Symbol	Min	Typ	Max	Unit
Input high voltage (XTAL/EXTAL)	V_{IHC}	$V_{DDA} - 0.8$	V_{DDA}	$V_{DDA} + 0.3$	V
Input low voltage (XTAL/EXTAL)	V_{ILC}	-0.3	—	0.5	V
Input high voltage	V_{IH}	2.0	—	5.5	V
Input low voltage	V_{IL}	-0.3	—	0.8	V
Input current low (pullups disabled)	I_{IL}	-1	—	1	µA
Input current high (pullups disabled)	I_{IH}	-1	—	1	µA
Output tri-state current low	I_{OZL}	-10	—	10	µA
Output tri-state current high	I_{OZH}	-10	—	10	µA
Output High Voltage	V_{OH}	$V_{DD} - 0.7$	—	—	V
Output Low Voltage	V_{OL}	—	—	0.4	V
Output High Current	I_{OH}	8	—	16	mA
Output Low Current	I_{OL}	8	—	16	mA
Input capacitance	C_{IN}	—	8	—	pF
Output capacitance	C_{OUT}	—	12	—	pF
V_{DD} supply current @ nominal voltage and 25 °C Run [1] Deep Stop[2] Light Stop[3]	I_{DD}[4]	 — — —	 70 100 2.6	 — — —	 mA µA mA
V_{DDIO} supply current @ nominal voltage and 25 °C Run[5]	I_{DDIO}	 —	 40	 —	 mA
V_{DDA} supply current @ nominal voltage and 25 °C Deep Stop[2]	I_{DDA}	 —	 60	 —	 µA
Low Voltage Interrupt[6]	V_{EI}	—	2.5	2.85	V
Low Voltage Interrupt Recovery Hysteresis	V_{EIH}	—	50	—	mV
Power on Reset[7]	POR	—	1.5	2.0	V

1. Run (operating) I_{DD} measured using external square wave clock source ($f_{osc} = 4$MHz) into XTAL. All inputs 0.2V from rail; no DC loads; outputs unloaded. All ports configured as inputs; measured with all modules enabled. PLL set to 240MHz out. Running Core, performing 50% NOP and 50% FIR. Clock at 120 MHz.

2. Deep Stop Mode - Operation frequency = 4 MHz, PLL set to 4 MHz, crystal oscillator and time of day module operating.

3. Light Stop Mode - Operation frequency = 120 MHz, PLL set to 240 MHz, crystal oscillator and time of day module operating.

4. I_{DD} includes current for core logic, internal memories, and all internal peripheral logic circuitry.

5. Running core and performing external memory access. Clock at 120 MHz.

6. When V_{DD} drops below V_{EI} max value, an interrupt is generated.

7. Power-on reset occurs whenever the digital supply drops below 1.8V. While power is ramping up, this signal remains active for as long as the internal 2.5V is below 1.8V no matter how long the ramp up rate is. The internally regulated voltage is typically 100 mV less than V_{DD} during ramp up until 2.5V is reached, at which time it self-regulates.

4.3 Supply Voltage Sequencing and Separation Cautions

Figure 3 shows two situations to avoid in sequencing the V_{DD} and V_{DDIO}, V_{DDA} supplies.
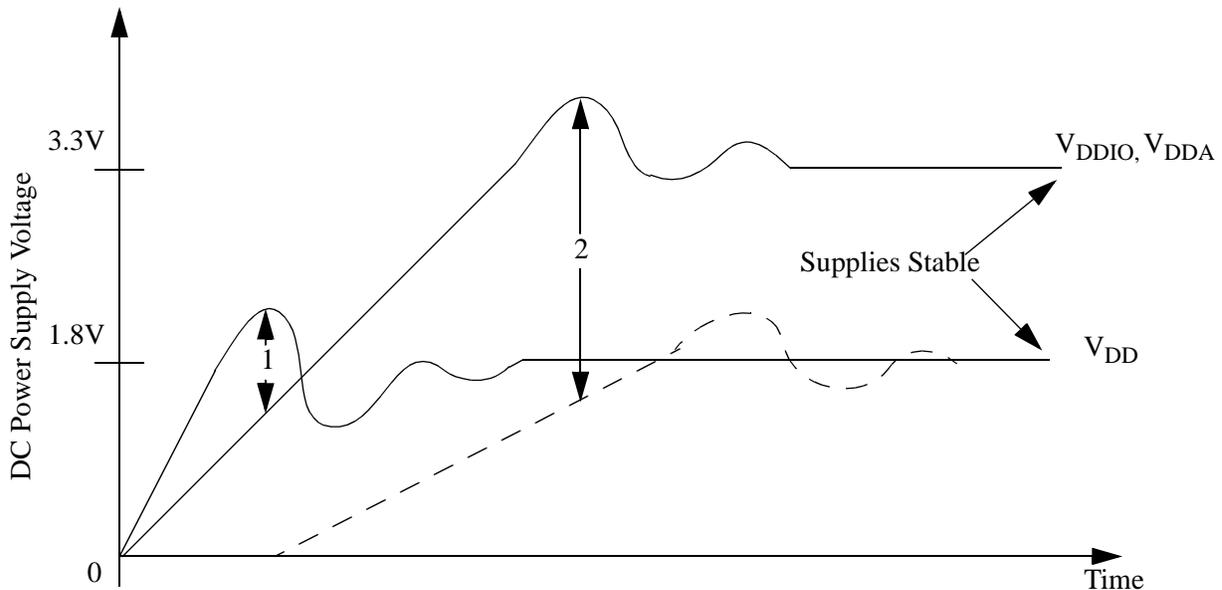
Notes: 1. V_{DD} rising before V_{DDIO}, V_{DDA}
2. V_{DDIO}, V_{DDA} rising much faster than V_{DD}

Figure 3. Supply Voltage Sequencing and Separation Cautions

V_{DD} should not be allowed to rise early (1). This is usually avoided by running the regulator for the V_{DD} supply (1.8V) from the voltage generated by the 3.3V V_{DDIO} supply, see **Figure 4**. This keeps V_{DD} from rising faster than V_{DDIO}.

V_{DD} should not rise so late that a large voltage difference is allowed between the two supplies (2). Typically this situation is avoided by using external discrete diodes in series between supplies, as shown in **Figure 4**. The series diodes forward bias when the difference between V_{DDIO} and V_{DD} reaches approximately 2.1, causing V_{DD} to rise as V_{DDIO} ramps up. When the V_{DD} regulator begins proper operation, the difference between supplies will typically be 0.8V and conduction through the diode chain reduces to essentially leakage current. During supply sequencing, the following general relationship should be adhered to:
$V_{DDIO} \geq V_{DD} \geq (V_{DDIO} - 2.1V)$

In practice, V_{DDA} is typically connected directly to V_{DDIO} with some filtering.
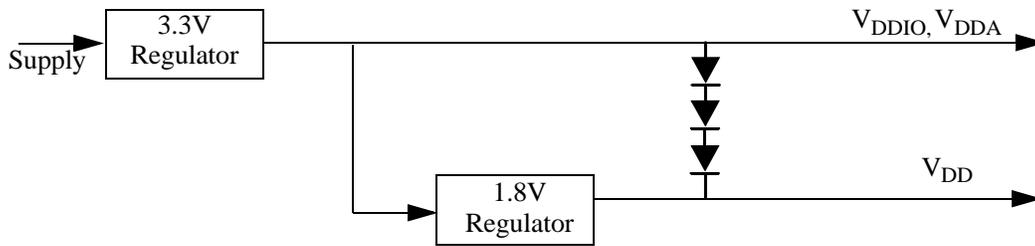
Figure 4. Example Circuit to Control Supply Sequencing

4.4 AC Electrical Characteristics

Timing waveforms in **Section 4.2** are tested with a V_{IL} maximum of 0.8 V and a V_{IH} minimum of 2.0 V for all pins except XTAL, which is tested using the input levels in **Section 4.2.** In **Figure 5** the levels of V_{IH} and V_{IL} for an input signal are shown.
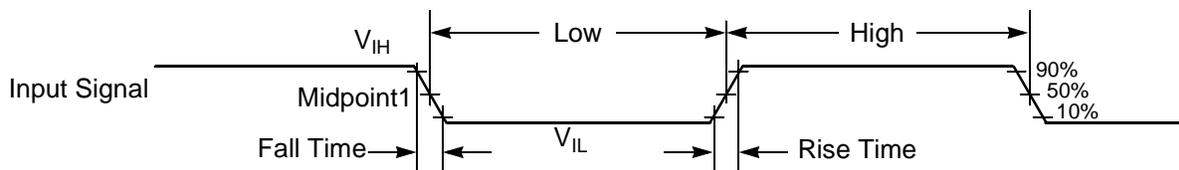
Note: The midpoint is $V_{IL} + (V_{IH} - V_{IL})/2$.

Figure 5. Input Signal Measurement References

Figure 6 shows the definitions of the following signal states:

- Active state, when a bus or signal is driven, and enters a low impedance state.
- Tri-stated, when a bus or signal is placed in a high impedance state.
- Data Valid state, when a signal level has reached V_{OL} or V_{OH}.
- Data Invalid state, when a signal level is in transition between V_{OL} and V_{OH}.
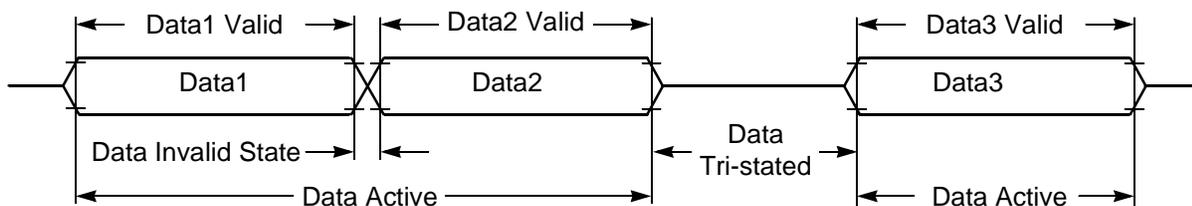
Figure 6. Signal States

4.5 External Clock Operation

The DSP56854 system clock can be derived from a crystal or an external system clock signal. To generate a reference frequency using the internal oscillator, a reference crystal must be connected between the EXTAL and XTAL pins.

4.5.1 Crystal Oscillator

The internal oscillator is designed to interface with a parallel-resonant crystal resonator in the frequency range specified for the external crystal in **Table 9**. In **Figure 7** a typical crystal oscillator circuit is shown. Follow the crystal supplier's recommendations when selecting a crystal, because crystal parameters determine the component values required to provide maximum stability and reliable start-up. The crystal and associated components should be mounted as close as possible to the EXTAL and XTAL pins to minimize output distortion and start-up stabilization time.

Crystal Frequency = 2–4 MHz (optimized for 4MHz)

EXTAL XTAL

R_z

Sample External Crystal Parameters:
$R_z = 10M\Omega$
TOD_SEL bit in CGM must be set to 0
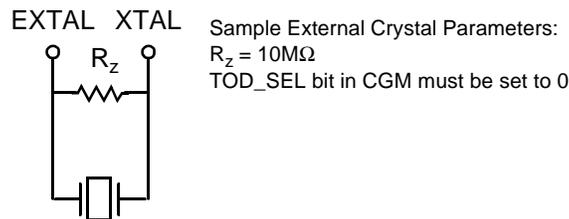
Figure 7. Crystal Oscillator

4.5.2 High Speed External Clock Source (> 4MHz)

The recommended method of connecting an external clock is given in **Figure 8.** The external clock source is connected to XTAL and the EXTAL pin is held at ground, V_{DDA}, or $V_{DDA}/2$. The TOD_SEL bit in CGM must be set to 0.

DSP56854

XTAL   EXTAL

External
Clock
(up to 240MHz)

GND, V_{DDA},
or $V_{DDA}/2$
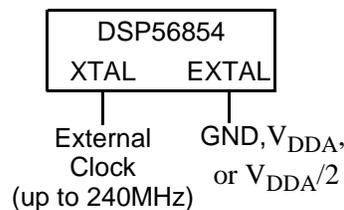
Figure 8. Connecting a High Speed External Clock Signal using XTAL

4.5.3 Low Speed External Clock Source (2-4MHz)

The recommended method of connecting an external clock is given in **Figure 9.** The external clock source is connected to XTAL and the EXTAL pin is held at $V_{DDA}/2$. The TOD_SEL bit in CGM must be set to 0.

```
    ┌─────────────┐
    │   DSP56854  │
    │ XTAL  EXTAL │
    └──┬──────┬───┘
       │      │
  External   V_DDA/2
   Clock
  (2-4MHz)
```
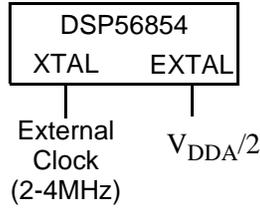
Figure 9. Connecting a Low Speed External Clock Signal using XTAL

Table 8. External Clock Operation Timing Requirements[4]

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62\text{-}1.98$V, $V_{DDIO} = V_{DDA} = 3.0\text{–}3.6$V, $T_A = -40°$ to $+120°$C, $C_L \le 50$pF, $f_{op} = 120$MHz

Characteristic	Symbol	Min	Typ	Max	Unit
Frequency of operation (external clock driver)[1]	f_{osc}	0	—	240	MHz
Clock Pulse Width[4]	t_{PW}	6.25	—	—	ns
External clock input rise time[2, 4]	t_{rise}	—	—	TBD	ns
External clock input fall time[3, 4]	t_{fall}	—	—	TBD	ns

1. See **Figure 8** for details on using the recommended connection of an external clock driver.
2. External clock input rise time is measured from 10% to 90%.
3. External clock input fall time is measured from 90% to 10%.
4. Parameters listed are guaranteed by design.

Note: The midpoint is $V_{IL} + (V_{IH} - V_{IL})/2$.
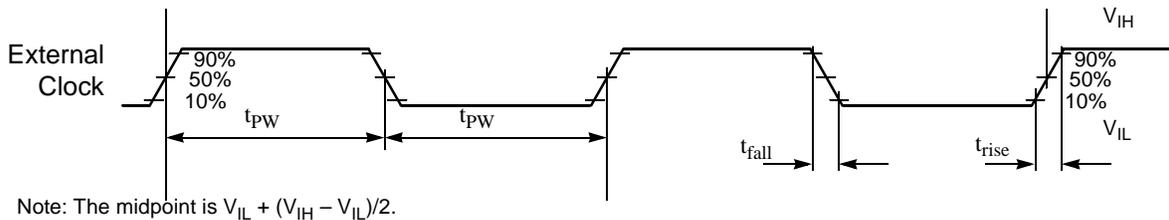
Figure 10. External Clock Timing

Table 9. PLL Timing

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62\text{-}1.98$V, $V_{DDIO} = V_{DDA} = 3.0\text{–}3.6$V, $T_A = -40°$ to $+120°$C, $C_L \le 50$pF, $f_{op} = 120$MHz

Characteristic	Symbol	Min	Typ	Max	Unit
External reference crystal frequency for the PLL[1]	f_{osc}	2	4	4	MHz
PLL output frequency	f_{clk}	40	—	240	MHz
PLL stabilization time [2]	t_{plls}	—	1	10	ms

1. An externally supplied reference clock should be as free as possible from any phase jitter for the PLL to work correctly. The PLL is optimized for 4MHz input crystal.
2. This is the minimum time required after the PLL setup is changed to ensure reliable operation.

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4.6 External Memory InterfaceTiming

The External Memory Interface is designed to access static memory and peripheral devices. **Figure 11** shows sample timing and parameters that are detailed in **Table 10**.

The timing of each parameter consists of both a fixed delay portion and a clock related portion; as well as user controlled wait states. The equation:

$$t = D + P * (M + W)$$

should be used to determine the actual time of each parameter. The terms in the above equation are defined as:

t   parameter delay time

D   fixed portion of the delay, due to on-chip path delays.

P   the period of the system clock, which determines the execution rate of the part (i.e. when the device is operating at 120 MHz, P = 8.33 ns).

M   Fixed portion of a clock period inherent in the design. This number is adjusted to account for possible clock duty cycle derating.

W   the sum of the applicable wait state controls. See the "Wait State Controls" column of **Table 10** for the applicable controls for each parameter. See the EMI chapter of the 83x Peripheral Manual for details of what each wait state field controls.

Some of the parameters contain two sets of numbers. These parameters have two different paths and clock edges that must be considered. Check both sets of numbers and use the smaller result. The appropriate entry may change if the operating frequency of the part changes.

The timing of write cycles is different when WWS = 0 than when WWS > 0. Therefore, some parameters contain two sets of numbers to account for this difference. The "Wait States Configuration" column of **Table 10** should be used to make the appropriate selection.
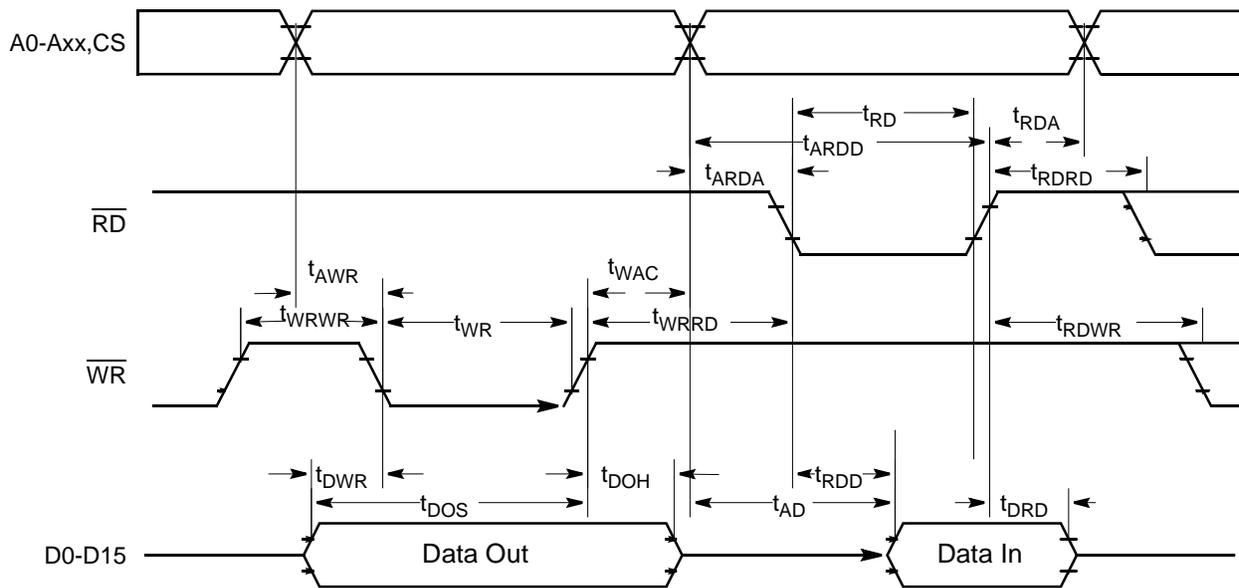
Note: During read-modify-write instructions and internal instructions, the address lines do not change state.

Figure 11. External Memory Interface Timing

Table 10. External Memory Interface Timing

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62\text{-}1.98$ V, $V_{DDIO} = V_{DDA} = 3.0\text{–}3.6$V, $T_A = –40°$ to $+120°$C, $C_L \leq 50$pF, $P = 8.333$ns

Characteristic	Symbol	Wait States Configuration	D	M	Wait States Controls	Unit
Address Valid to WR Asserted	t_{AWR}	WWS=0	-0.79	0.50	WWSS	ns
		WWS>0	-1.98	0.69		
WR Width Asserted to WR Deasserted	t_{WR}	WWS=0	-0.86	0.19	WWS	ns
		WWS>0	-0.01	0.00		
Data Out Valid to WR Asserted	t_{DWR}	WWS=0	-1.52	0.00	WWSS	ns
		WWS=0	- 5.69	0.25		
		WWS>0	-2.10	0.19		
		WWS>0	-4.66	0.50		
Valid Data Out Hold Time after WR Deasserted	t_{DOH}		-1.47	0.25	WWSH	ns
Valid Data Out Set Up Time to WR Deasserted	t_{DOS}		-2.36	0.19	WWS,WWSS	ns
			-4.67	0.50		
Valid Address after WR Deasserted	t_{WAC}		-1.60	0.25	WWSH	
RD Deasserted to Address Invalid	t_{RDA}		- 0.44	0.00	RWSH	ns
Address Valid to RD Deasserted	t_{ARDD}		-2.07	1.00	RWSS,RWS	ns
Valid Input Data Hold after RD Deasserted	t_{DRD}		0.00	N/A[1]	—	ns
RD Assertion Width	t_{RD}		-1.34	1.00	RWS	ns
Address Valid to Input Data Valid	t_{AD}		-10.27	1.00	RWSS,RWS	ns
			-13.5	1.19		
Address Valid to RD Asserted	t_{ARDA}		- 0.94	0.00	RWSS	ns
RD Asserted to Input Data Valid	t_{RDD}		-9.53	1.00	RWSS,RWS	ns
			-12.64	1.19		
WR Deasserted to RD Asserted	t_{WRRD}		-0.75	0.25	WWSH,RWSS	ns
RD Deasserted to RD Asserted	t_{RDRD}		-0.16[2]	0.00	RWSS,RWSH	ns
WR Deasserted to WR Asserted	t_{WRWR}	WWS=0	-0.44	0.75	WWSS, WWSH	ns
		WWS>0	-0.11	1.00		
RD Deasserted to WR Asserted	t_{RDWR}		0.14	0.50	MDAR, BMDAR, RWSH, WWSS	ns
			-0.57	0.69		

1. N/A since device captures data before it deasserts RD
2. If RWSS = RWSH = 0, RD does not deassert during back-to-back reads and D=0.00 should be used.

4.7 Reset, Stop, Wait, Mode Select, and Interrupt Timing

Table 11. Reset, Stop, Wait, Mode Select, and Interrupt Timing[1, 2]

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62\text{-}1.98V$, $V_{DDIO} = V_{DDA} = 3.0\text{–}3.6V$, $T_A = -40°$ to $+120°C$, $C_L \le 50pF$, $f_{op} = 120MHz$

Characteristic	Symbol	Min	Max	Unit	See Figure
$\overline{\text{RESET}}$ Assertion to Address, Data and Control Signals High Impedance	t_{RAZ}	—	11	ns	**Figure 12**
Minimum $\overline{\text{RESET}}$ Assertion Duration[3]	t_{RA}	30	—	ns	**Figure 12**
$\overline{\text{RESET}}$ Deassertion to First External Address Output	t_{RDA}	—	120T	ns	**Figure 12**
Edge-sensitive Interrupt Request Width	t_{IRW}	1T + 3	—	ns	**Figure 13**
$\overline{\text{IRQA}}$, $\overline{\text{IRQB}}$ Assertion to External Data Memory Access Out Valid, caused by first instruction execution in the interrupt service routine	t_{IDM}	—	18T	ns	**Figure 14**
$\overline{\text{IRQA}}$, $\overline{\text{IRQB}}$ Assertion to General Purpose Output Valid, caused by first instruction execution in the interrupt service routine	t_{IG}	—	18T	ns	**Figure 14**
$\overline{\text{IRQA}}$ Low to First Valid Interrupt Vector Address Out recovery from Wait State[4]	t_{IRI}	—	13T	ns	**Figure 15**
$\overline{\text{IRQA}}$ Width Assertion to Recover from Stop State[5] Fast[6] Normal[7, 8]	t_{IW} 	 4T 8ET	 — —	 ns ns	**Figure 16**
Delay from $\overline{\text{IRQA}}$ Assertion to Fetch of first instruction (exiting Stop) Fast[5] Normal[6,7]	t_{IF} 	 — —	 13T 25ET	 ns ns	**Figure 16**
$\overline{\text{RSTO}}$ pulse width[7] normal operation internal reset mode	t_{RSTO} 	 128ET 8ET	 — —	 — —	**Figure 17**

1. In the formulas, T = clock cycle. For $f_{op} = 120MHz$ operation and $f_{ipb} = 60MHz$, T = 8.33ns.

2. Parameters listed are guaranteed by design.

3. At reset, the PLL is disabled and bypassed. The part is then put into Run mode and t_{clk} assumes the period of the source clock, t_{xtal}, t_{extal} or t_{osc}.

4. The minimum is specified for the duration of an edge-sensitive IRQA interrupt required to recover from the Wait state. This is not the minimum required so that the IRQA interrupt is accepted.

5. This interrupt instruction fetch is visible on the pins only in Mode 3.

6. Fast stop mode:
   Fast stop recovery applies when fast stop mode recovery is requested (OMR bit 6 is set to 1). The PLL and the master clock are unaffected by stop mode entry. Recovery takes one less cycle and t_{clk} will continue with the same value it had before stop mode was entered.

7. Normal stop mode:
   As a power saving feature, normal stop mode disables and bypasses the PLL. Stop mode will then shut down the master clock, recovery will take an extra cycle (to restart the clock), and t_{clk} will resume at the input clock source rate.

8. ET = External Clock period; for an external crystal frequency of 4MHz, ET=250ns.
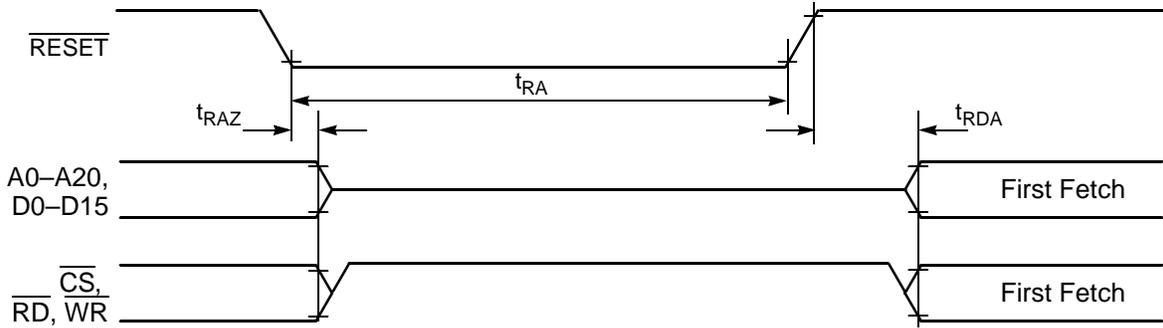
Figure 12. Asynchronous Reset Timing
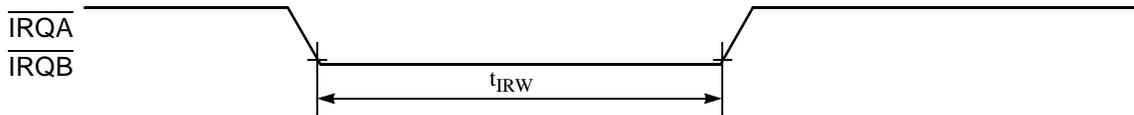
Figure 13. External Interrupt Timing (Negative-Edge-Sensitive)

a) First Interrupt Instruction Execution

b) General Purpose I/O
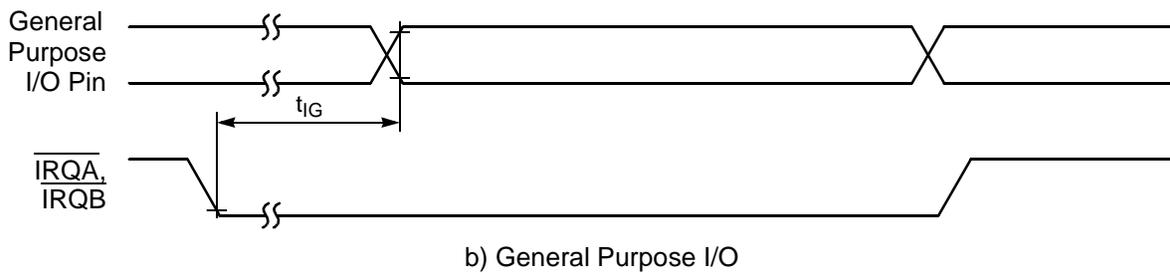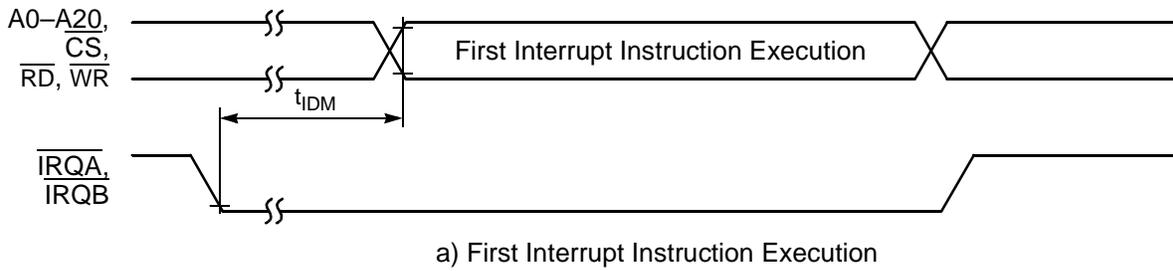
Figure 14. External Level-Sensitive Interrupt Timing
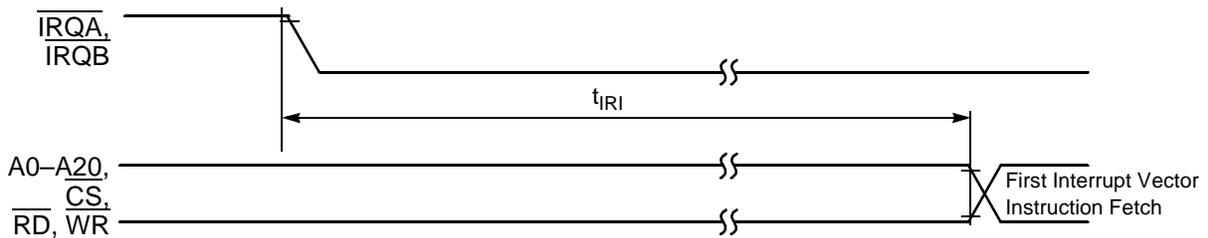
Figure 15. Interrupt from Wait State Timing
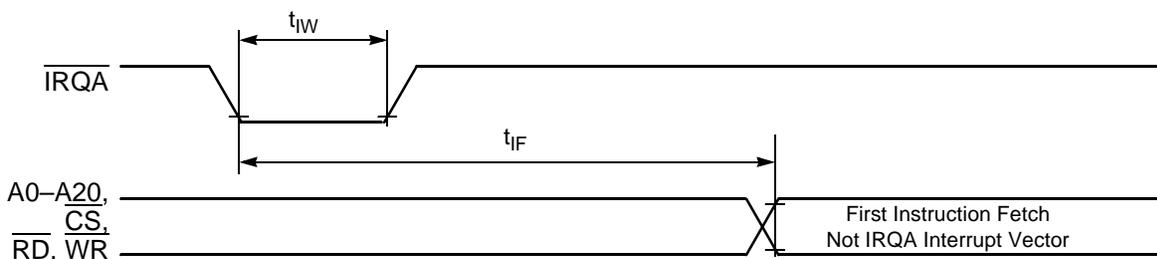
DSP56854 Preliminary Technical Data **MOTOROLA**

Figure 16. Recovery from Stop State Using Asynchronous Interrupt Timing
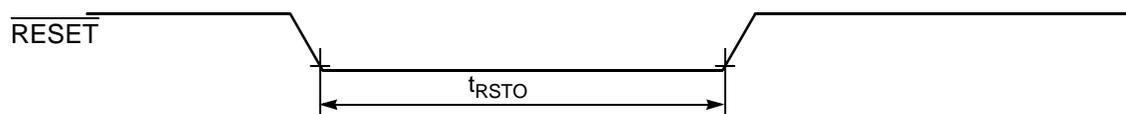

Figure 17. Reset Output Timing

4.8 Host Interface Port

Table 12. Host Interface Port Timing[1]

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62$-1.98V, $V_{DDIO} = V_{DDA} = 3.0$–3.6V, $T_A = -40°$ to $+120°$C, $C_L \leq 50$pF, $f_{op} = 120$MHz

Characteristic	Symbol	Min	Max	Unit	See Figure
Access time	TACKDV	—	13	ns	**Figure 18**
Disable time	TACKDZ	3	—	ns	**Figure 18**
Time to disassert	TACKREQH	3.5	9	ns	**Figure 18** **Figure 21**
Lead time	TREQACKL	0	—	ns	**Figure 18** **Figure 21**
Access time	TRADV	—	13	ns	**Figure 19** **Figure 20**
Disable time	TRADX	5	—	ns	**Figure 19** **Figure 20**
Disable time	TRADZ	3	—	ns	**Figure 19** **Figure 20**
Setup time	TDACKS	3	—	ns	**Figure 21**
Hold time	TACKDH	1	—	ns	**Figure 21**
Setup time	TADSS	3	—	ns	**Figure 22** **Figure 23**
Hold time	TDSAH	1	—	ns	**Figure 22** **Figure 23**
Pulse width	TWDS	5	—	ns	**Figure 22** **Figure 23**
Time to re-assert 1. After second write in 16-bit mode 2. After first write in 16-bit mode or after write in 8-bit mode	TACKREQL	4T + 5 5	5T + 9 13	ns ns	**Figure 18**, **Figure 21**

1.   The formulas: T = clock cycle. f ipb = 60MHz, T = 16.7ns.
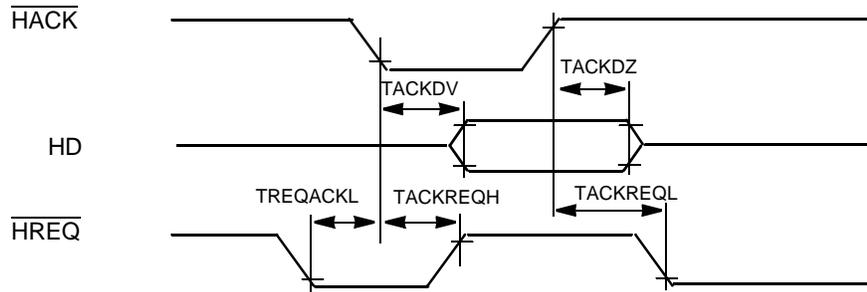
Figure 18. DSP-to-Host DMA Read Mode
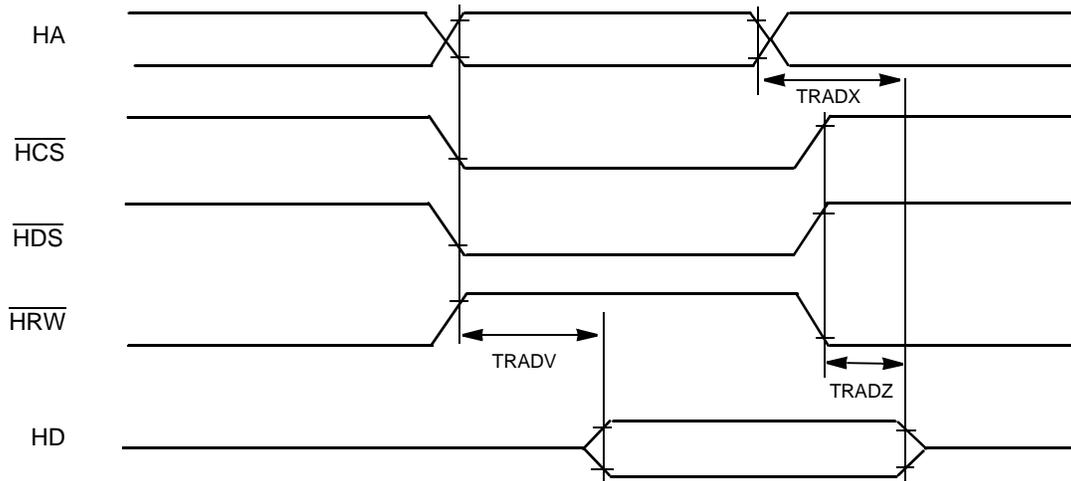
Figure 19. Single Strobe Read Mode
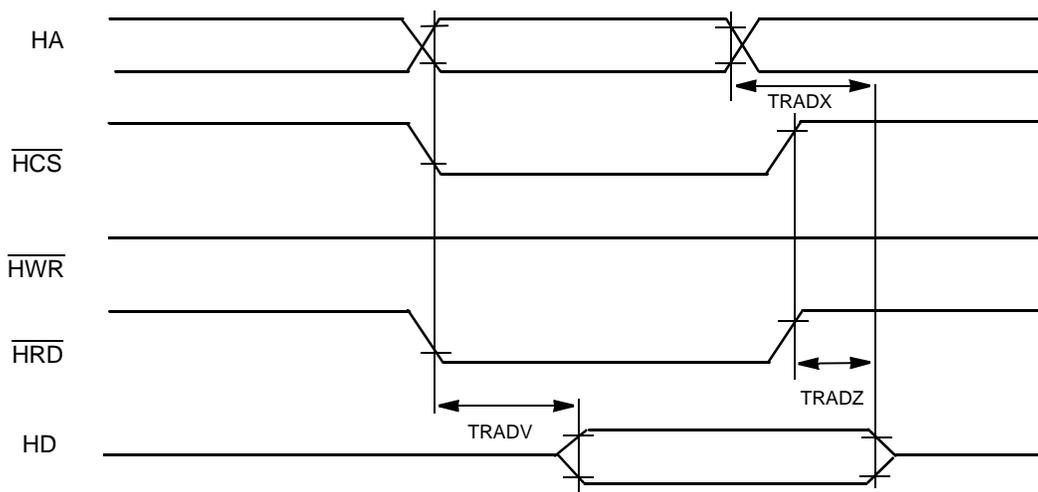
Figure 20. Dual Strobe Read Mode
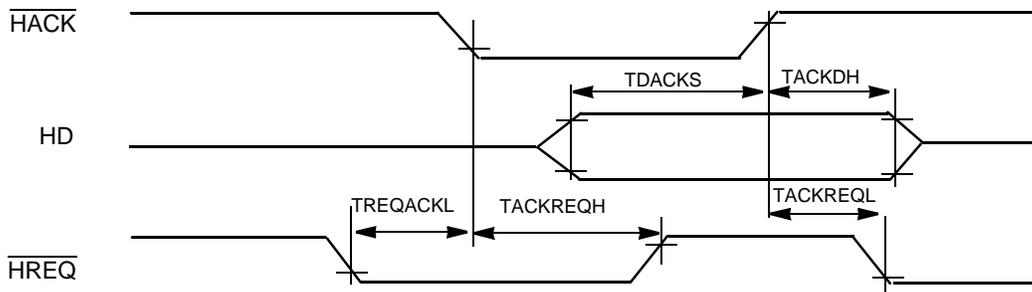
Figure 21. Host-to-DSP DMA Write Mode
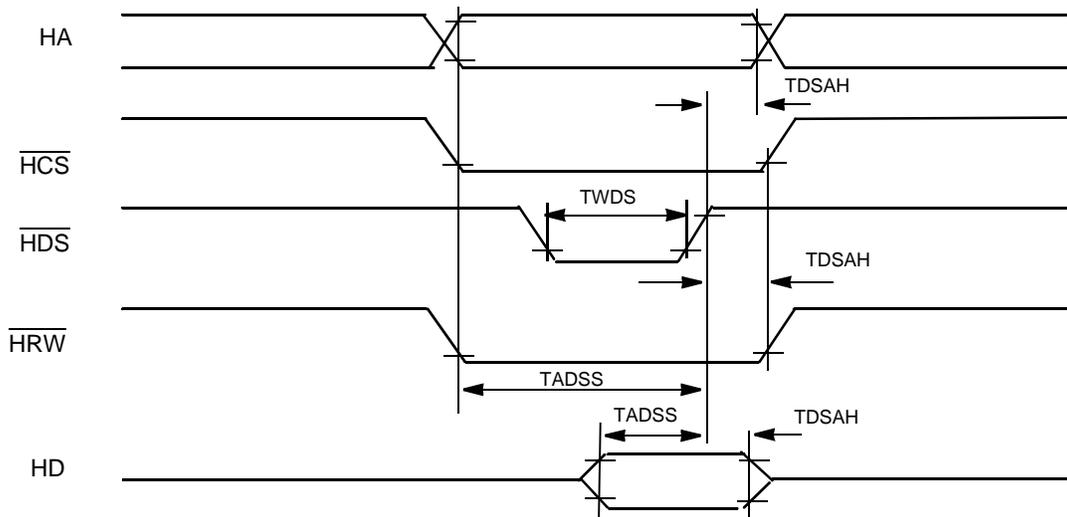
Figure 22. Single Strobe Write Mode
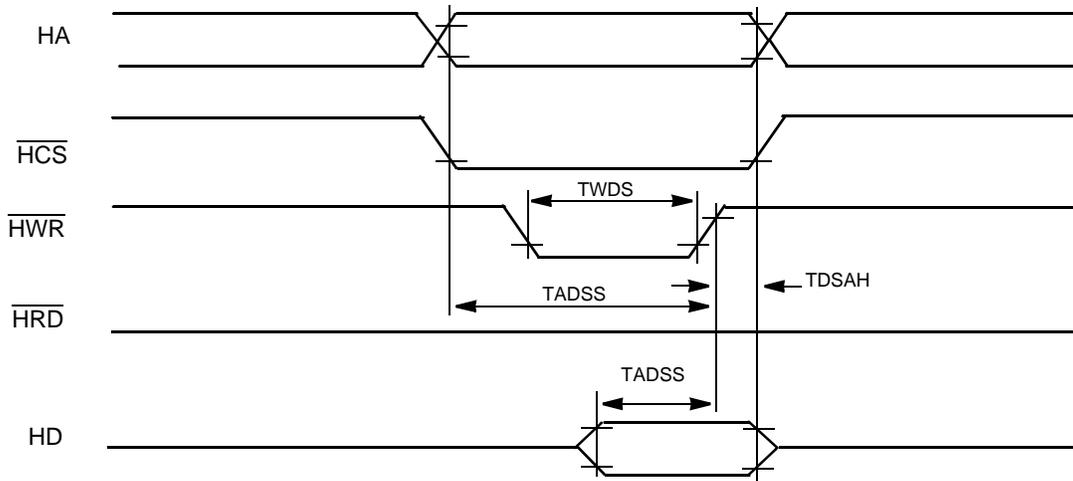
Figure 23. Dual Strobe Write Mode

4.9 Serial Peripheral Interface (SPI) Timing

Table 13. SPI Timing [1]

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62\text{-}1.98$V, $V_{DDIO} = V_{DDA} = 3.0\text{-}3.6$V, $T_A = -40°$ to $+120°$C, $C_L \leq 50$pF, $f_{op} = 120$MHz

Characteristic	Symbol	Min	Max	Unit	See Figure
Cycle time Master Slave	t_C	 25 25	 — —	 ns ns	Figures 24, 25, 26, 27
Enable lead time Master Slave	t_{ELD}	 — 12.5	 — —	 ns ns	Figure 27
Enable lag time Master Slave	t_{ELG}	 — 12.5	 — —	 ns ns	Figure 27
Clock (SCLK) high time Master Slave	t_{CH}	 9 12.5	 — —	ns ns	Figures 24, 25, 26, 27
Clock (SCLK) low time Master Slave	t_{CL}	 12 12.5	 — —	 ns ns	Figure 27
Data set-up time required for inputs Master Slave	t_{DS}	 10 2	 — —	 ns ns	Figures 24, 25, 26, 27
Data hold time required for inputs Master Slave	t_{DH}	 0 2	 — —	 ns ns	Figures 24, 25, 26, 27

Table 13. SPI Timing (Continued)[1]

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62$-1.98V, $V_{DDIO} = V_{DDA} = 3.0$–3.6V, $T_A = -40°$ to $+120°$C, $C_L \leq 50$pF, $f_{op} = 120$MHz

Access time (time to data active from high-impedance state) Slave	t_A	 5	 15	ns ns	Figure 27
Disable time (hold time to high-impedance state) Slave	t_D	 2	 9	ns ns	Figure 27
Data valid for outputs Master Slave (after enable edge)	t_{DV}	 — —	 2 14	ns ns	Figures 24, 25, 26, 27
Data invalid Master Slave	t_{DI}	 0 0	 — —	ns ns	Figures 24, 25, 26, 27
Rise time Master Slave	t_R	 — —	 11.5 10.0	ns ns	Figures 24, 25, 26, 27
Fall time Master Slave	t_F	 — —	 9.7 9.0	ns ns	Figures 24, 25, 26, 27

1. Parameters listed are guaranteed by design.
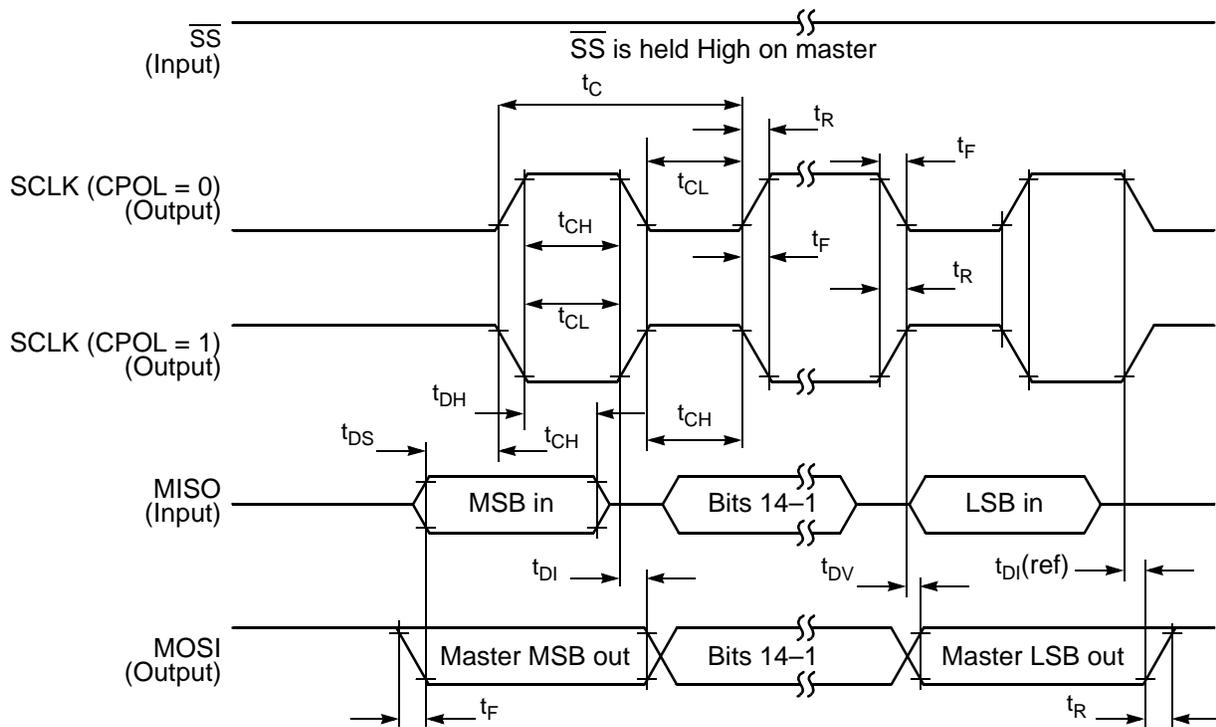
Figure 24. SPI Master Timing (CPHA = 0)
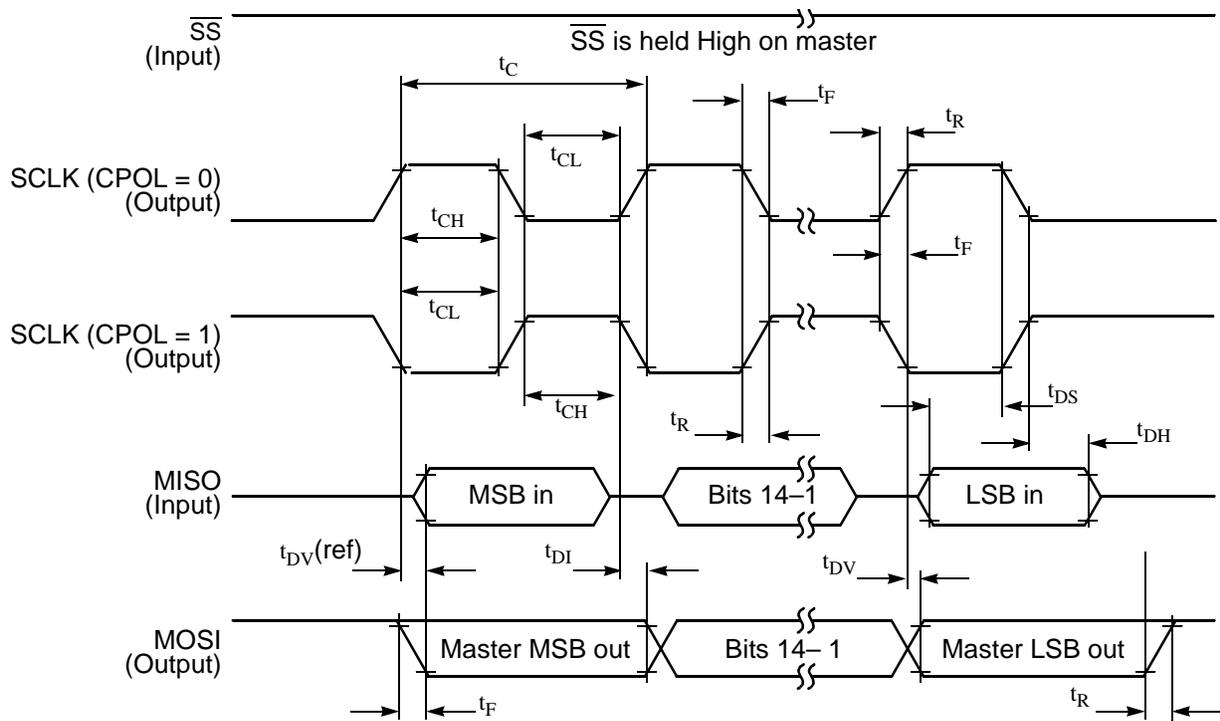
Figure 25. SPI Master Timing (CPHA = 1)
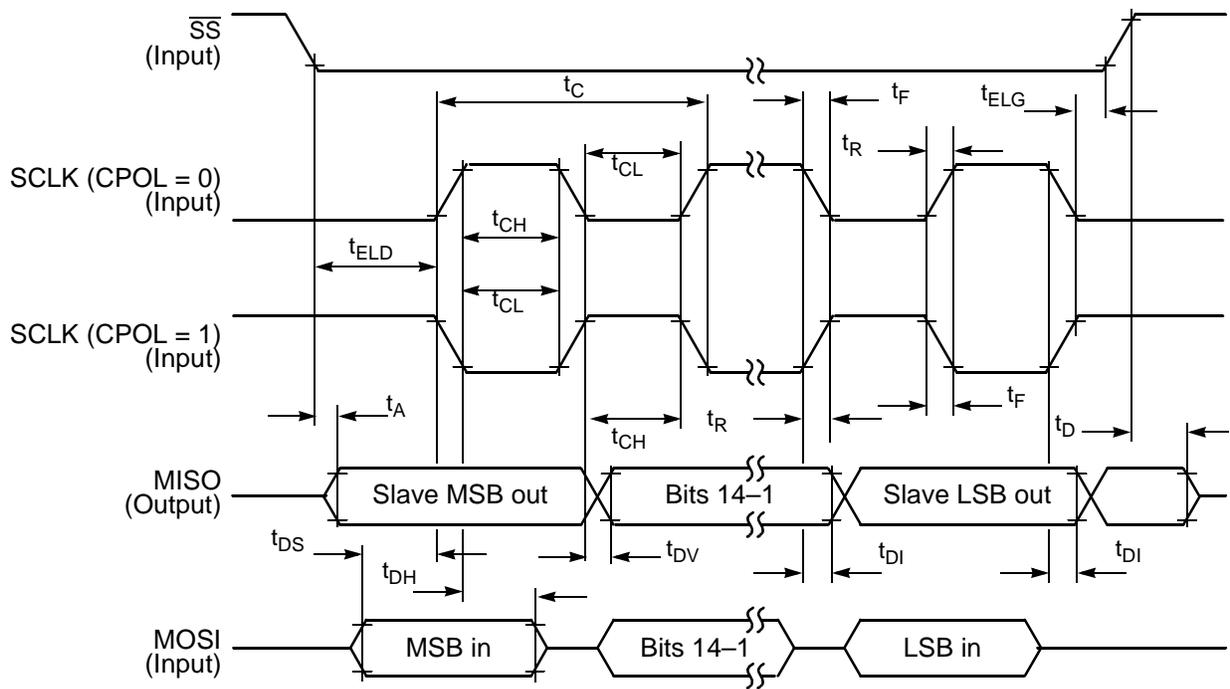
Figure 26. SPI Slave Timing (CPHA = 0)
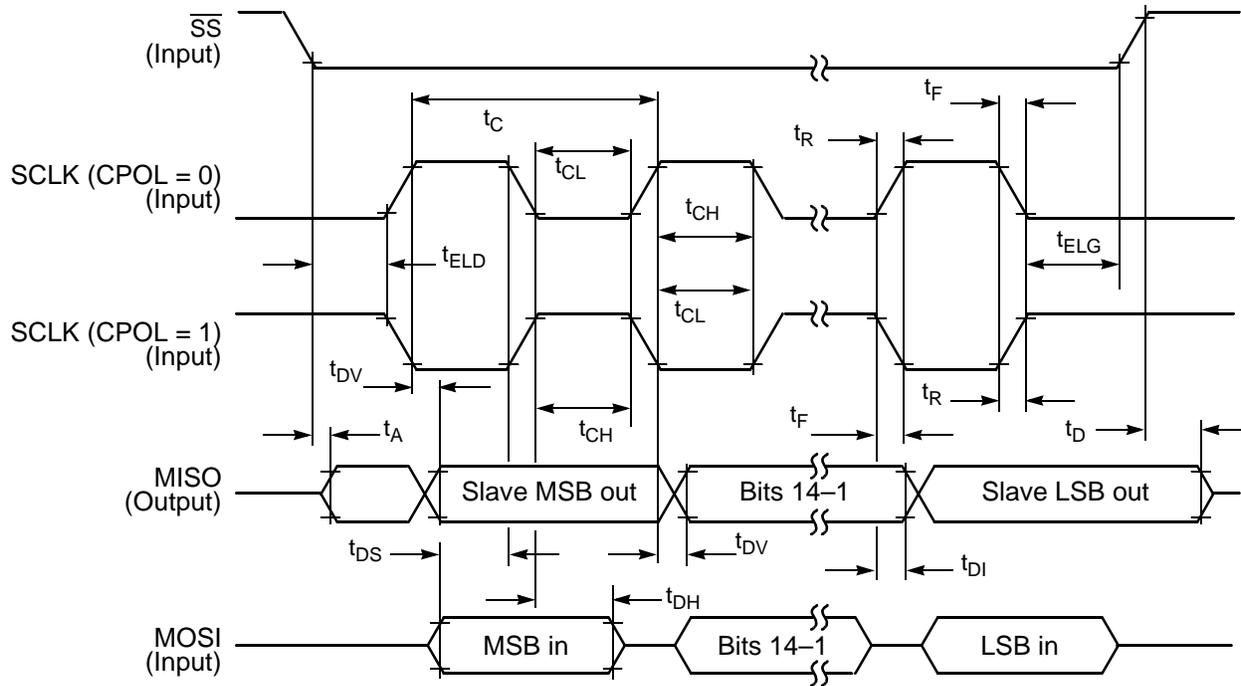
Figure 27. SPI Slave Timing (CPHA = 1)

4.10 Quad Timer Timing

Table 14. Quad Timer Timing[1, 2]

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62\text{-}1.98V$, $V_{DDIO} = V_{DDA} = 3.0\text{–}3.6V$, $T_A = -40°$ to $+120°C$, $C_L \leq 50pF$, $f_{op} = 120MHz$

Characteristic	Symbol	Min	Max	Unit
Timer input period	P_{IN}	2T + 3	—	ns
Timer input high/low period	P_{INHL}	1T + 3	—	ns
Timer output period	P_{OUT}	2T - 3	—	ns
Timer output high/low period	P_{OUTHL}	1T - 3	—	ns

1. In the formulas listed, T = clock cycle. For f_{op} = 120MHz operation and fipb = 60MHz, T = 8.33ns.
2. Parameters listed are guaranteed by design.
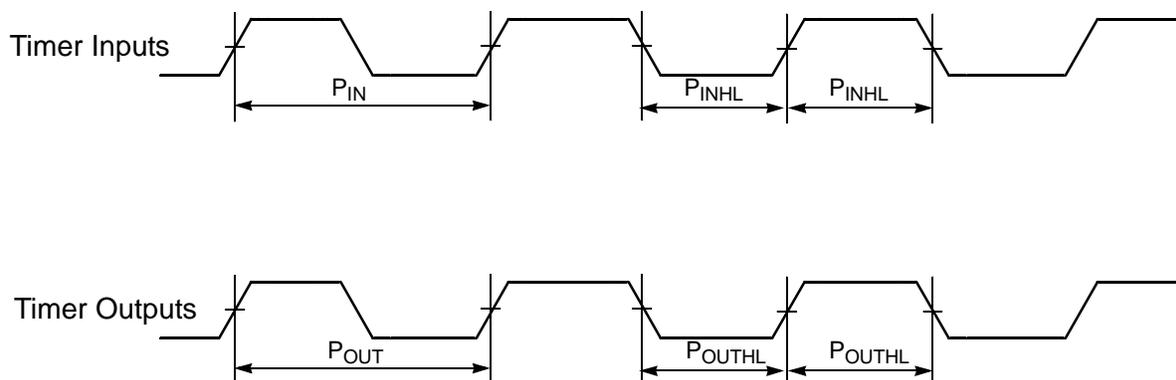
Figure 28. Timer Timing

4.11 Enhanced Synchronous Serial Interface (ESSI) Timing

Table 15. ESSI Master Mode[1] Switching Characteristics

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62\text{-}1.98$V, $V_{DDIO} = V_{DDA} = 3.0\text{–}3.6$V, $T_A = -40°$ to $+120°$C, $C_L \leq 50$pF, $f_{op} = 120$MHz

Parameter	Symbol	Min	Typ	Max	Units
SCK frequency	fs	—	—	15[2]	MHz
SCK period[3]	t_{SCKW}	66.7	—	—	ns
SCK high time	t_{SCKH}	33.4[4]	—	—	ns
SCK low time	t_{SCKL}	33.4[4]	—	—	ns
Output clock rise/fall time	—	—	4	—	ns
Delay from SCK high to SC2 (bl) high - Master[5]	t_{TFSBHM}	-1.0	—	1.0	ns
Delay from SCK high to SC2 (wl) high - Master[5]	t_{TFSWHM}	-1.0	—	1.0	ns
Delay from SC0 high to SC1 (bl) high - Master[5]	t_{RFSBHM}	-1.0	—	1.0	ns
Delay from SC0 high to SC1 (wl) high - Master[5]	t_{RFSWHM}	-1.0	—	1.0	ns
Delay from SCK high to SC2 (bl) low - Master[5]	t_{TFSBLM}	-1.0	—	1.0	ns
Delay from SCK high to SC2 (wl) low - Master[5]	t_{TFSWLM}	-1.0	—	1.0	ns
Delay from SC0 high to SC1 (bl) low - Master[5]	t_{RFSBLM}	-1.0	—	1.0	ns
Delay from SC0 high to SC1 (wl) low - Master[5]	t_{RFSWLM}	-1.0	—	1.0	ns
SCK high to STD enable from high impedance - Master	t_{TXEM}	-0.1	—	2	ns
SCK high to STD valid - Master	t_{TXVM}	-0.1	—	2	ns
SCK high to STD not valid - Master	t_{TXNVM}	-0.1	—	—	ns
SCK high to STD high impedance - Master	t_{TXHIM}	-4	—	0	ns
SRD Setup time before SC0 low - Master	t_{SM}	4	—	—	ns

Table 15. ESSI Master Mode[1] Switching Characteristics (Continued)

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62$-1.98V, $V_{DDIO} = V_{DDA} = 3.0$–3.6V, $T_A = -40°$ to $+120°$C, $C_L \leq 50$pF, $f_{op} = 120$MHz

Parameter	Symbol	Min	Typ	Max	Units
SRD Hold time after SC0 low - Master	t_{HM}	4	—	—	ns
Synchronous Operation (in addition to standard internal clock parameters)					
SRD Setup time before SCK low - Master	t_{TSM}	4	—	—	ns
SRD Hold time after SCK low - Master	t_{THM}	4	—	—	ns

1. Master mode is internally generated clocks and frame syncs
2. Max clock frequency is IP_clk/4 = 60MHz / 4 = 15MHz for an 120MHz part.
3. All the timings for the ESSI are given for a non-inverted serial clock polarity (TSCKP=0 in SCR2 and RSCKP=0 in SCSR) and a non-inverted frame sync (TFSI=0 in SCR2 and RFSI=0 in SCSR). If the polarity of the clock and/or the frame sync have been inverted, all the timings remain valid by inverting the clock signal SCK/SC0 and/or the frame sync SC2/SC1 in the tables and in the figures.
4. 50 percent duty cycle
5. bl = bit length; wl = word length
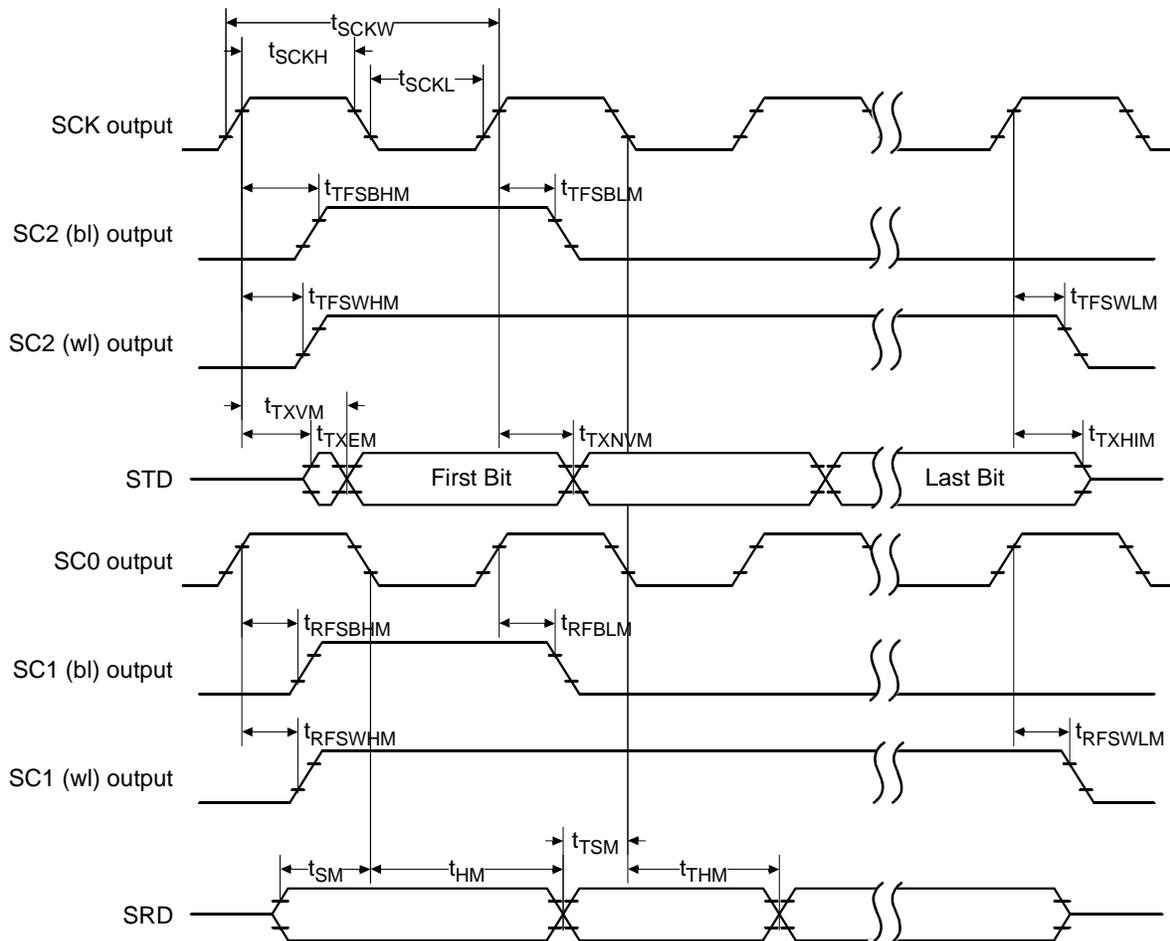
Figure 29. Master Mode Timing Diagram

Table 16: ESSI Slave Mode[1] Switching Characteristics

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62$-1.98V, $V_{DDIO} = V_{DDA} = 3.0$–3.6V, $T_A = -40°$ to $+120°$C, $C_L \leq 50$pF, $f_{op} = 120$MHz

Parameter	Symbol	Min	Typ	Max	Units
SCK frequency	fs	—	—	15[2]	MHz
SCK period[3]	t_{SCKW}	66.7	—	—	ns
SCK high time	t_{SCKH}	33.4[4]	—	—	ns
SCK low time	t_{SCKL}	33.4[4]	—	—	ns
Output clock rise/fall time	—	—	4	—	ns
Delay from SCK high to SC2 (bl) high - Slave[5]	t_{TFSBHS}	-1	—	29	ns
Delay from SCK high to SC2 (wl) high - Slave[5]	t_{TFSWHS}	-1	—	29	ns
Delay from SC0 high to SC1 (bl) high - Slave[5]	t_{RFSBHS}	-1	—	29	ns
Delay from SC0 high to SC1 (wl) high - Slave[5]	t_{RFSWHS}	-1	—	29	ns
Delay from SCK high to SC2 (bl) low - Slave[5]	t_{TFSBLS}	-29	—	29	ns
Delay from SCK high to SC2 (wl) low - Slave[5]	t_{TFSWLS}	-29	—	29	ns
Delay from SC0 high to SC1 (bl) low - Slave[5]	t_{RFSBLS}	-29	—	29	ns
Delay from SC0 high to SC1 (wl) low - Slave[5]	t_{RFSWLS}	-29	—	29	ns
SCK high to STD enable from high impedance - Slave	t_{TXES}	—	—	15	ns
SCK high to STD valid - Slave	t_{TXVS}	4	—	15	ns
SC2 high to STD enable from high impedance (first bit) - Slave	t_{FTXES}	4	—	15	ns
SC2 high to STD valid (first bit) - Slave	t_{FTXVS}	4	—	15	ns
SCK high to STD not valid - Slave	t_{TXNVS}	4	—	15	ns
SCK high to STD high impedance - Slave	t_{TXHIS}	4	—	15	ns
SRD Setup time before SC0 low - Slave	t_{SS}	4	—	—	ns
SRD Hold time after SC0 low - Slave	t_{HS}	4	—	—	ns
Synchronous Operation (in addition to standard external clock parameters)					
SRD Setup time before SCK low - Slave	t_{TSS}	4	—	—	ns
SRD Hold time after SCK low - Slave	t_{THS}	4	—	—	ns

1. Slave mode is externally generated clocks and frame syncs
2. Max clock frequency is IP_clk/4 = 60MHz / 4 = 15MHz for a 120MHz part.
3. All the timings for the ESSI are given for a non-inverted serial clock polarity (TSCKP=0 in SCR2 and RSCKP=0 in SCSR) and a non-inverted frame sync (TFSI=0 in SCR2 and RFSI=0 in SCSR). If the polarity of the clock and/or the frame sync have been inverted, all the timings remain valid by inverting the clock signal SCK/SC0 and/or the frame sync SC2/SC1 in the tables and in the figures.
4. 50 percent duty cycle
5. bl = bit length; wl = word length
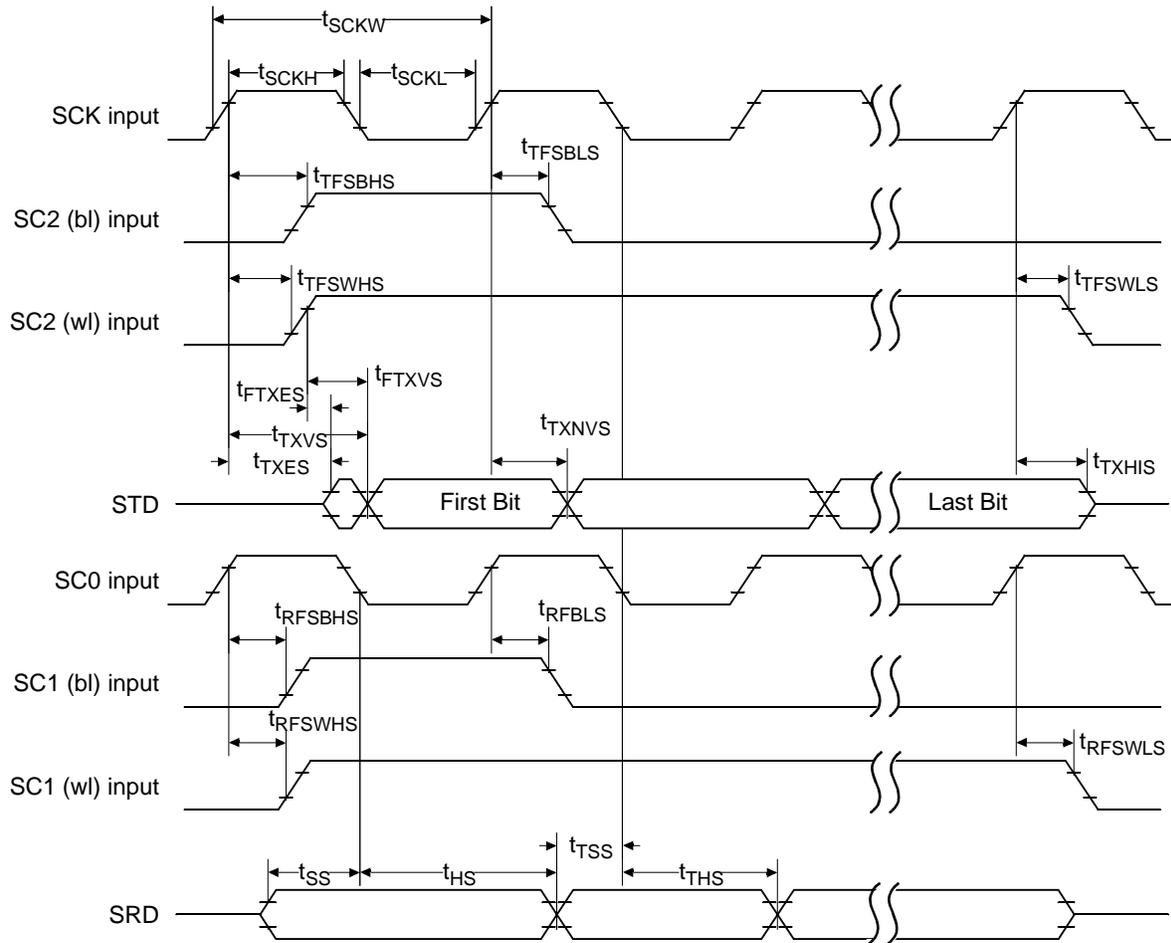
**Figure 30. Slave Mode Clock Timing**

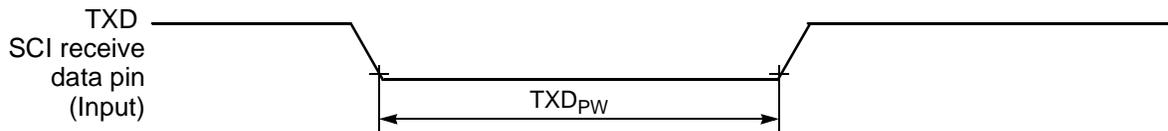# 4.12 Serial Communication Interface (SCI) Timing

Table 17. SCI Timing[4]

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62$-1.98V, $V_{DDIO} = V_{DDA} = 3.0$–3.6V, $T_A = -40°$ to $+120°$C, $C_L \leq 50$pF, $f_{op} = 120$MHz

Characteristic	Symbol	Min	Max	Unit
Baud Rate[1]	BR	—	$(f_{MAX})/(32)$	Mbps
RXD[2] Pulse Width	RXD_{PW}	0.965/BR	1.04/BR	ns
TXD[3] Pulse Width	TXD_{PW}	0.965/BR	1.04/BR	ns

1. f_{MAX} is the frequency of operation of the system clock in MHz.
2. The RXD pin in SCI0 is named RXD0 and the RXD pin in SCI1 is named RXD1.
3. The TXD pin in SCI0 is named TXD0 and the TXD pin in SCI1 is named TXD1.
4. Parameters listed are guaranteed by design.
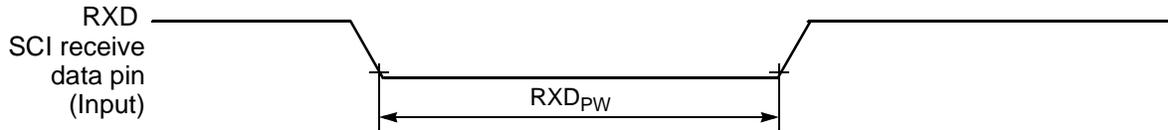
Figure 31. RXD Pulse Width

Figure 32. TXD Pulse Width

4.13 JTAG Timing

Table 18. JTAG Timing[1, 3]

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62\text{-}1.98$V, $V_{DDIO} = V_{DDA} = 3.0\text{--}3.6$V, $T_A = -40°$ to $+120°$C, $C_L \le 50$pF, $f_{op} = 120$MHz

Characteristic	Symbol	Min	Max	Unit
TCK frequency of operation[2]	f_{OP}	DC	30	MHz
TCK cycle time	t_{CY}	33.3	—	ns
TCK clock pulse width	t_{PW}	16.6	—	ns
TMS, TDI data setup time	t_{DS}	3	—	ns
TMS, TDI data hold time	t_{DH}	3	—	ns
TCK low to TDO data valid	t_{DV}	—	12	ns
TCK low to TDO tri-state	t_{TS}	—	10	ns
$\overline{TRST}$ assertion time	t_{TRST}	35	—	ns
$\overline{DE}$ assertion time	t_{DE}	4T	—	ns

1. Timing is both wait state and frequency dependent. For the values listed, T = clock cycle. For 120MHz operation, T = 8.33ns.

2. TCK frequency of operation must be less than 1/4 the processor rate.

3. Parameters listed are guaranteed by design.

$V_M = V_{IL} + (V_{IH} - V_{IL})/2$
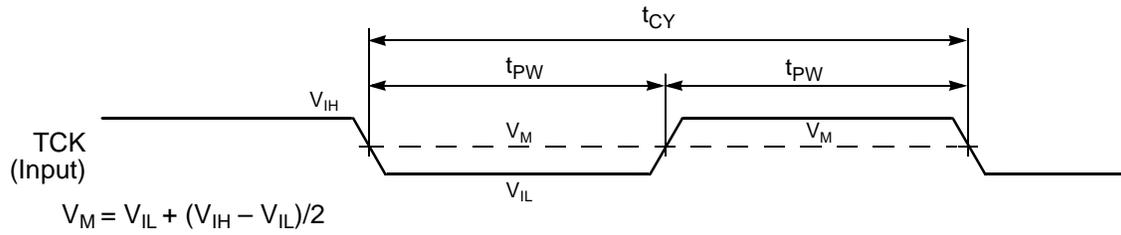
Figure 33. Test Clock Input Timing Diagram
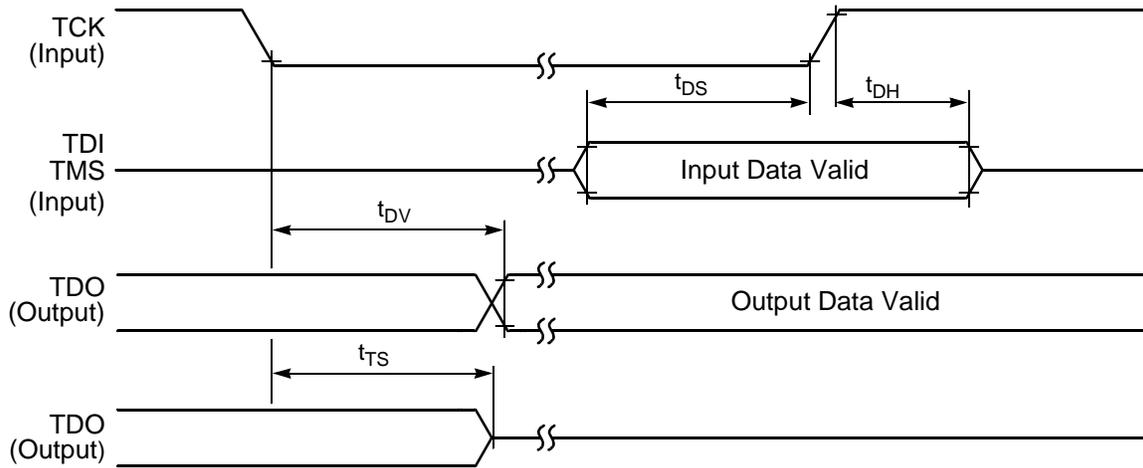
Figure 34. Test Access Port Timing Diagram

Figure 35. $\overline{\text{TRST}}$ Timing Diagram

Figure 36. Enhanced OnCE—Debug Event

4.14 GPIO Timing

Table 19. GPIO Timing[1, 2]

Operating Conditions: $V_{SS} = V_{SSIO} = V_{SSA} = 0$ V, $V_{DD} = 1.62\text{-}1.98$V, $V_{DDIO} = V_{DDA} = 3.0\text{–}3.6$V, $T_A = -40°$ to $+120°$C, $C_L \leq 50$pF, $f_{op} = 120$MHz

Characteristic	Symbol	Min	Max	Unit
GPIO input period	P_{IN}	2T + 3	—	ns
GPIO input high/low period	P_{INHL}	1T + 3	—	ns
GPIO output period	P_{OUT}	2T - 3	—	ns
GPIO output high/low period	P_{OUTHL}	1T - 3	—	ns

1. In the formulas listed, T = clock cycle. For $f_{op} = 120$MHz operation and fipb = 60MHz, T = 8.33ns

2. Parameters listed are guaranteed by design.
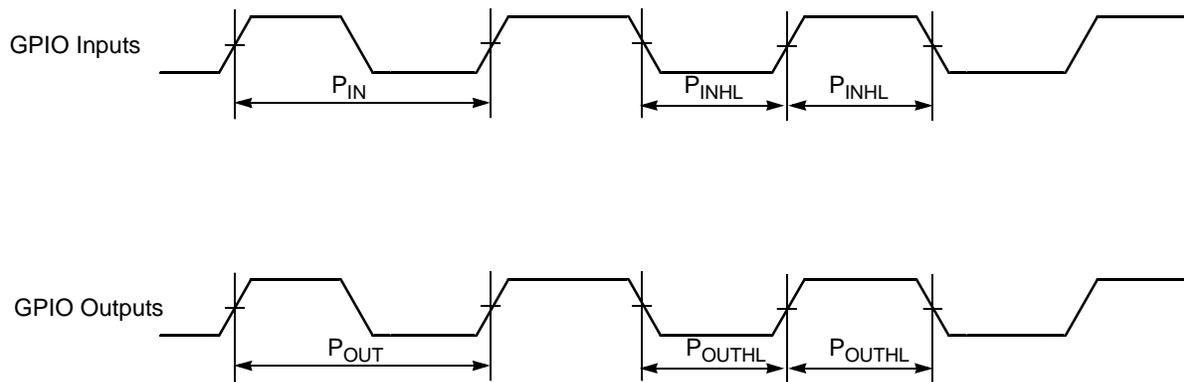
Figure 37. GPIO Timing

Part 5 Packaging

5.1 Package and Pin-Out Information DSP56854

This section contains package and pin-out information for the 128-pin LQFP configuration of the DSP56854.
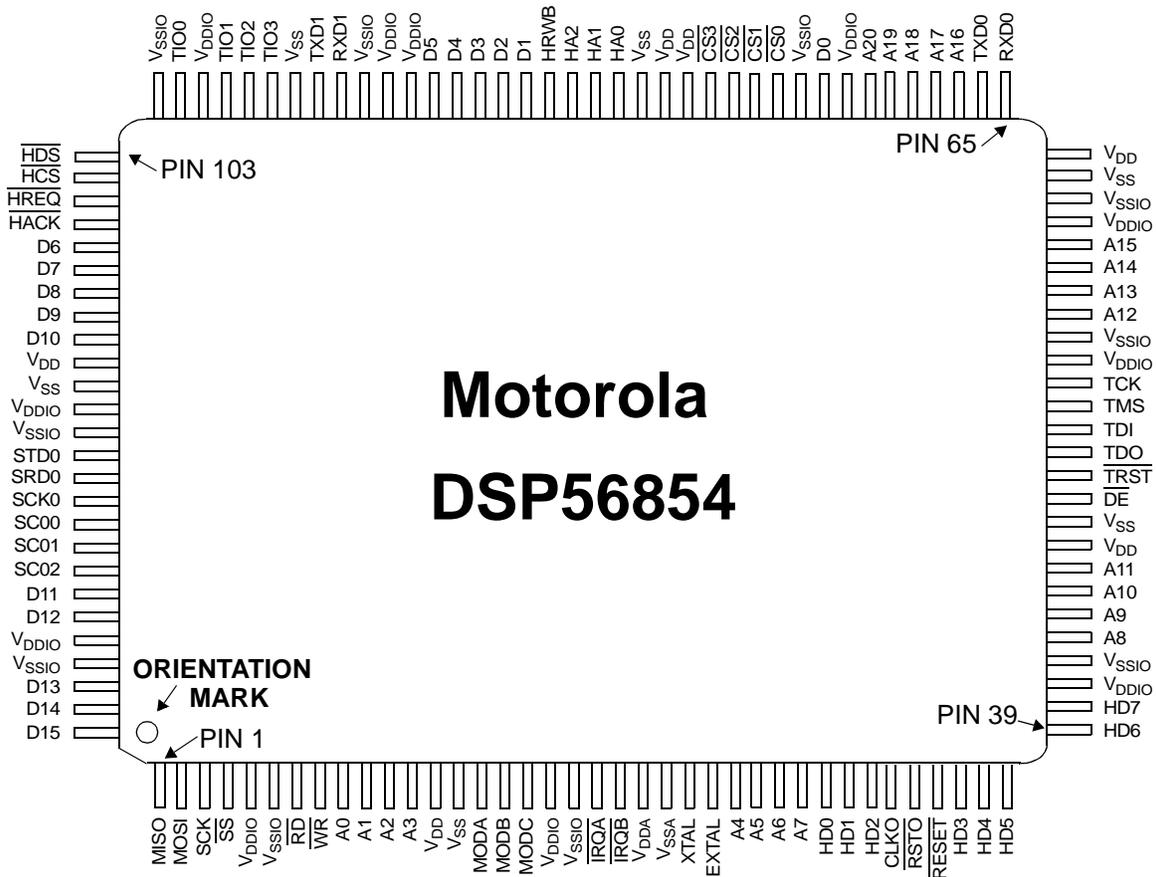
Figure 38. Top View, DSP56854 128-pin LQFP Package

Table 20. DSP56854 Pin Identification by Pin Number

Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name
1	MISO	33	CLKO	65	RXD0	97	TIO3
2	MOSI	34	$\overline{\text{RSTO}}$	66	TXDO	98	TIO2
3	SCK	35	$\overline{\text{RESET}}$	67	A16	99	TIO1
4	$\overline{\text{SS}}$	36	HD3	68	A17	100	V_{DDIO}
5	V_{DDIO}	37	HD4	69	A18	101	TIO0
6	V_{SSIO}	38	HD5	70	A19	102	V_{SSIO}
7	$\overline{\text{RD}}$	39	HD6	71	A20	103	$\overline{\text{HDS}}$
8	$\overline{\text{WR}}$	40	HD7	72	V_{DDIO}	104	$\overline{\text{HCS}}$
9	A0	41	V_{DDIO}	73	D0	105	$\overline{\text{HREQ}}$
10	A1	42	V_{SSIO}	74	V_{SSIO}	106	$\overline{\text{HACK}}$
11	A2	43	A8	75	$\overline{\text{CS0}}$	107	D6
12	A3	44	A9	76	$\overline{\text{CS1}}$	108	D7
13	V_{DD}	45	A10	77	$\overline{\text{CS2}}$	109	D8
14	V_{SS}	46	A11	78	$\overline{\text{CS3}}$	110	D9
15	MODA	47	V_{DD}	79	V_{DD}	111	D10
16	MODB	48	V_{SS}	80	V_{DD}	112	V_{DD}
17	MODC	49	$\overline{\text{DE}}$	81	V_{SS}	113	V_{SS}
18	V_{DDIO}	50	$\overline{\text{TRST}}$	82	HA0	114	V_{DDIO}
19	V_{SSIO}	51	TDO	83	HA1	115	V_{SSIO}
20	$\overline{\text{IRQA}}$	52	TDI	84	HA2	116	STD0
21	$\overline{\text{IRQB}}$	53	TMS	85	HRWB	117	SRD0
22	V_{DDA}	54	TCK	86	D1	118	SCK0
23	V_{SSA}	55	V_{DDIO}	87	D2	119	SC00
24	XTAL	56	V_{SSIO}	88	D3	120	SC01
25	EXTAL	57	A12	89	D4	121	SC02
26	A4	58	A13	90	D5	122	D11
27	A5	59	A14	91	V_{DDIO}	123	D12
28	A6	60	A15	92	V_{DDIO}	124	V_{DDIO}
29	A7	61	V_{DDIO}	93	V_{SSIO}	125	V_{SSIO}
30	HD0	62	V_{SSIO}	94	RXD1	126	D13
31	HD1	63	V_{SS}	95	TXD1	127	D14
32	HD2	64	V_{DD}	96	V_{SS}	128	D15
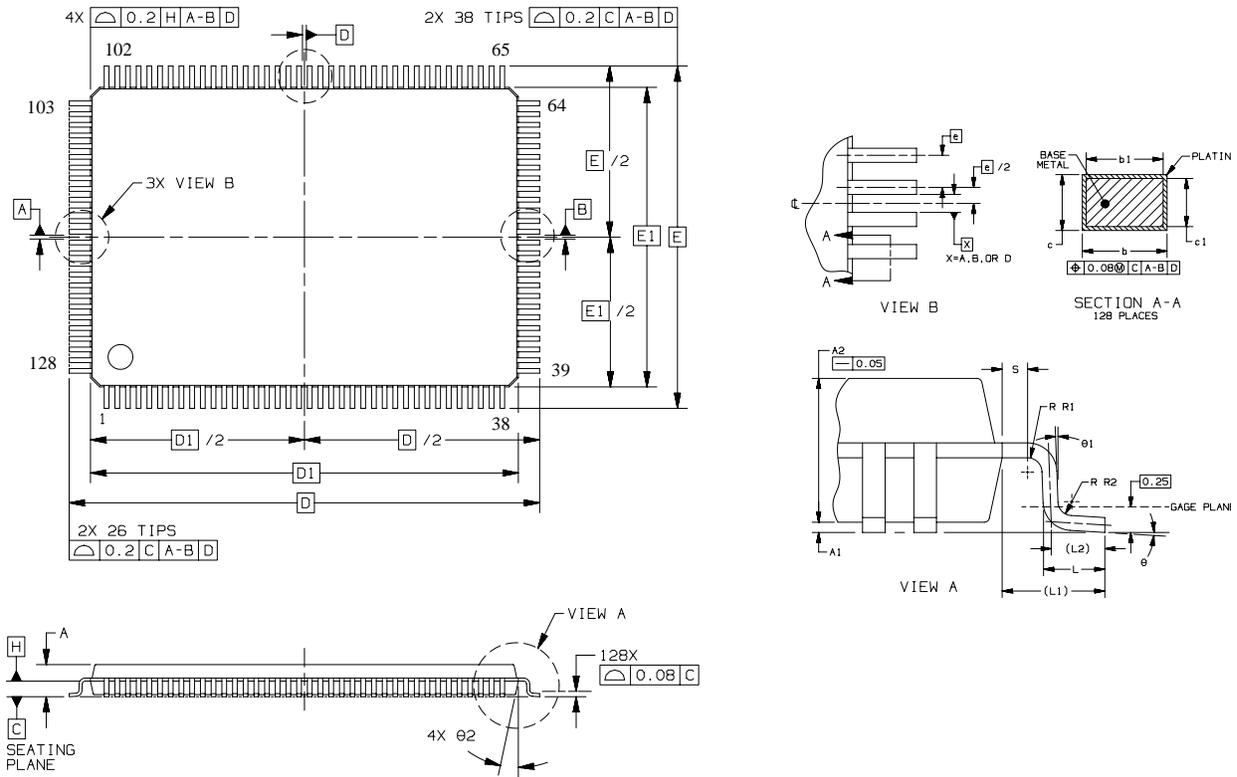
NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DATUM PLANE H IS LOCATED AT BOTTOM OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE BOTTOM OF THE PARTING LINE.
4. DATUMS A, B, AND D TO BE DETERMINED AT DATUM PLANE H.
5. DIMENSIONS D AND E TO BE DETERMINED AT SEATING PLANE C.
6. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25 PER SIDE. DIMENSIONS D1 AND E1 DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.
7. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. DAMBAR PROTRUSION SHALL NOT CAUSE THE b DIMENSION TO EXCEED 0.35.

DIM	MILLIMETERS	
	MIN	MAX
A	---	1.60
A1	0.05	0.15
A2	1.35	1.45
b	0.17	0.27
b1	0.17	0.23
c	0.09	0.20
c1	0.09	0.16
D	22.00 BSC	
D1	20.00BSC	
e	0.50 BSC	
E	16.00 BSC	
E1	14.00 BSC	
L	0.45	0.75
L1	1.00 REF	
L2	0.50 REF	
S	0.20	---
R1	0.08	---
R2	0.08	0.20
θ	0°	7°
$\theta 1$	0°	---
$\theta 2$	11°	13°

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Figure 39. 128-pin LQFP Mechanical Information

Part 6 Design Considerations

6.1 Thermal Design Considerations

An estimation of the chip junction temperature, T_J, in °C can be obtained from the equation:

Equation 1: $T_J = T_A + (P_D \times R_{\theta JA})$

Where:

T_A = ambient temperature °C
$R_{\theta JA}$ = package junction-to-ambient thermal resistance °C/W
P_D = power dissipation in package

Historically, thermal resistance has been expressed as the sum of a junction-to-case thermal resistance and a case-to-ambient thermal resistance:

Equation 2: $R_{\theta JA} = R_{\theta JC} + R_{\theta CA}$

Where:

$R_{\theta JA}$ = package junction-to-ambient thermal resistance °C/W
$R_{\theta JC}$ = package junction-to-case thermal resistance °C/W
$R_{\theta CA}$ = package case-to-ambient thermal resistance °C/W

$R_{\theta JC}$ is device-related and cannot be influenced by the user. The user controls the thermal environment to change the case-to-ambient thermal resistance, $R_{\theta CA}$. For example, the user can change the air flow around the device, add a heat sink, change the mounting arrangement on the Printed Circuit Board (PCB), or otherwise change the thermal dissipation capability of the area surrounding the device on the PCB. This model is most useful for ceramic packages with heat sinks; some 90% of the heat flow is dissipated through the case to the heat sink and out to the ambient environment. For ceramic packages, in situations where the heat flow is split between a path to the case and an alternate path through the PCB, analysis of the device thermal performance may need the additional modeling capability of a system level thermal simulation tool.

The thermal performance of plastic packages is more dependent on the temperature of the PCB to which the package is mounted. Again, if the estimations obtained from $R_{\theta JA}$ do not satisfactorily answer whether the thermal performance is adequate, a system level model may be appropriate.

A complicating factor is the existence of three common definitions for determining the junction-to-case thermal resistance in plastic packages:

- Measure the thermal resistance from the junction to the outside surface of the package (case) closest to the chip mounting area when that surface has a proper heat sink. This is done to minimize temperature variation across the surface.

- Measure the thermal resistance from the junction to where the leads are attached to the case. This definition is approximately equal to a junction to board thermal resistance.

- Use the value obtained by the equation $(T_J - T_T)/P_D$ where T_T is the temperature of the package case determined by a thermocouple.

As noted above, the junction-to-case thermal resistances quoted in this data sheet are determined using the first definition. From a practical standpoint, that value is also suitable for determining the junction temperature from a case thermocouple reading in forced convection environments. In natural convection, using the junction-to-case thermal resistance to estimate junction temperature from a thermocouple reading on the case of the package will estimate a junction temperature slightly hotter than actual. Hence, the new

thermal metric, Thermal Characterization Parameter, or Ψ_{JT}, has been defined to be $(T_J - T_T)/P_D$. This value gives a better estimate of the junction temperature in natural convection when using the surface temperature of the package. Remember that surface temperature readings of packages are subject to significant errors caused by inadequate attachment of the sensor to the surface and to errors caused by heat loss to the sensor. The recommended technique is to attach a 40-gauge thermocouple wire and bead to the top center of the package with thermally conductive epoxy.

6.2 Electrical Design Considerations

> **CAUTION**
>
> **This device contains protective circuitry to guard against damage due to high static voltage or electrical fields. However, normal precautions are advised to avoid application of any voltages higher than maximum rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate voltage level.**

Use the following list of considerations to assure correct DSP operation:

- Provide a low-impedance path from the board power supply to each V_{DD} pin on the DSP, and from the board ground to each V_{SS} (GND) pin.

- The minimum bypass requirement is to place six 0.01–0.1 μF capacitors positioned as close as possible to the package supply pins. The recommended bypass configuration is to place one bypass capacitor on each of the ten V_{DD}/V_{SS} pairs, including $V_{DDA}/V_{SSA.}$

- Ensure that capacitor leads and associated printed circuit traces that connect to the chip V_{DD} and V_{SS} (GND) pins are less than 0.5 inch per capacitor lead.

- Use at least a four-layer Printed Circuit Board (PCB) with two inner layers for V_{DD} and GND.

- Bypass the V_{DD} and GND layers of the PCB with approximately 100 μF, preferably with a high-grade capacitor such as a tantalum capacitor.

- Because the DSP output signals have fast rise and fall times, PCB trace lengths should be minimal.

- Consider all device loads as well as parasitic capacitance due to PCB traces when calculating capacitance. This is especially critical in systems with higher capacitive loads that could create higher transient currents in the V_{DD} and GND circuits.

- All inputs must be terminated (i.e., not allowed to float) using CMOS levels.

- Take special care to minimize noise levels on the V_{DDA} and V_{SSA} pins.

- When using Wired-OR mode on the SPI or the $\overline{IRQx}$ pins, the user must provide an external pull-up device.

- Designs that utilize the $\overline{\text{TRST}}$ pin for JTAG port or Enhance OnCE module functionality (such as development or debugging systems) should allow a means to assert $\overline{\text{TRST}}$ whenever $\overline{\text{RESET}}$ is asserted, as well as a means to assert $\overline{\text{TRST}}$ independently of $\overline{\text{RESET}}$. Designs that do not require debugging functionality, such as consumer products, should tie these pins together.

- The internal POR (Power on Reset) will reset the part at power on with $\overline{\text{reset}}$ asserted or pulled high but requires that $\overline{\text{TRST}}$ be asserted at power on.

Part 7 Ordering Information

Table 21 lists the pertinent information needed to place an order. Consult a Motorola Semiconductor sales office or authorized distributor to determine availability and to order parts.

Table 21. DSP56854 Ordering Information

Part	Supply Voltage	Package Type	Pin Count	Frequency (MHz)	Order Number
DSP56854	1.8V, 3.3V	Low-Profile Quad Flat Pack (LQFP)	128	120	DSP56854FG120

How to reach us:
USA/EUROPE/Locations Not Listed: Motorola Literature Distribution; P.O. Box 5405, Denver, Colorado 80217. 1–303–675–2140 or 1–800–441–2447

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ASIA/PACIFIC: Motorola Semiconductors H.K. Ltd.; Silicon Harbour Centre, 2 Dai King Street, Tai Po Industrial Estate, Tai Po, N.T., Hong Kong. 852–26668334

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